



HIGH-SPEED 2.5V 256/128K x 36 ASYNCHRONOUS DUAL-PORT STATIC RAM WITH 3.3V OR 2.5V INTERFACE

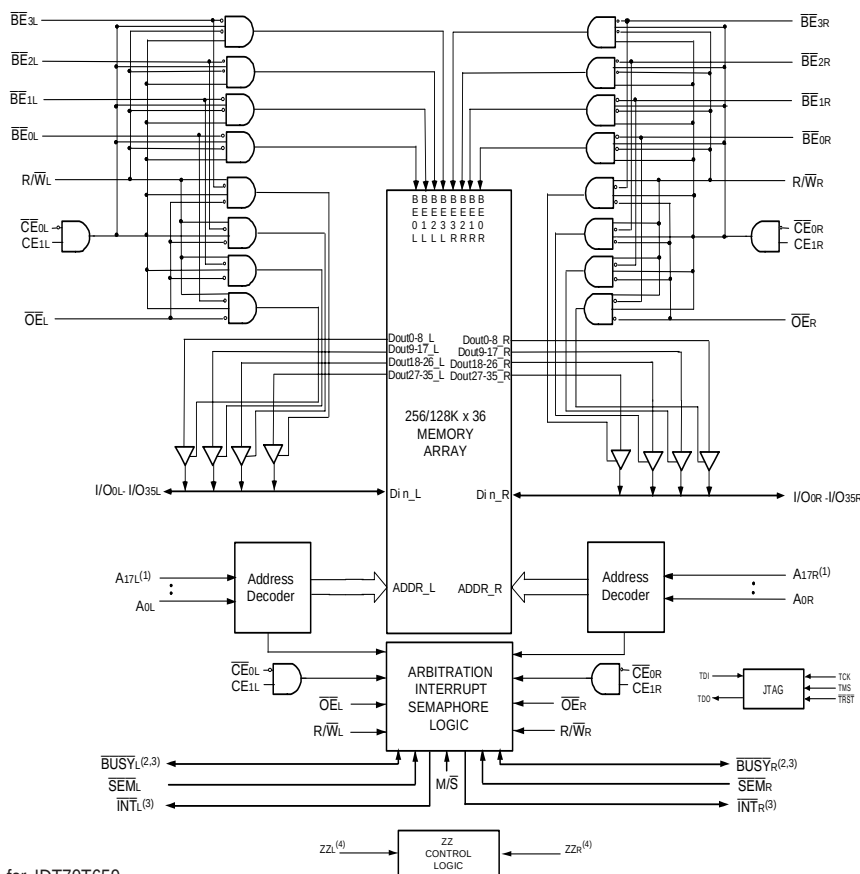
IDT70T651/9S

LEAD FINISH (SnPb) ARE IN EOL PROCESS - LAST TIME BUY EXPIRES JUNE 15, 2018

Features

- ♦ True Dual-Port memory cells which allow simultaneous access of the same memory location
- ♦ High-speed access
 - Commercial: 10/12/15ns (max.)
 - Industrial: 10/12ns (max.)
- ♦ RapidWrite Mode simplifies high-speed consecutive write cycles
- ♦ Dual chip enables allow for depth expansion without external logic
- ♦ IDT70T651/9 easily expands data bus width to 72 bits or more using the Master/Slave select when cascading more than one device
- ♦ $\overline{M/\overline{S}} = V_{IH}$ for $\overline{BUSY}$ output flag on Master, $\overline{M/\overline{S}} = V_{IL}$ for $\overline{BUSY}$ input on Slave
- ♦ Busy and Interrupt Flags
- ♦ On-chip port arbitration logic
- ♦ Full on-chip hardware support of semaphore signaling between ports
- ♦ Fully asynchronous operation from either port
- ♦ Separate byte controls for multiplexed bus and bus matching compatibility
- ♦ Sleep Mode Inputs on both ports
- ♦ Supports JTAG features compliant to IEEE 1149.1
- ♦ Single 2.5V ($\pm 100mV$) power supply for core
- ♦ LVTTTL-compatible, selectable 3.3V ($\pm 150mV$)/2.5V ($\pm 100mV$) power supply for I/Os and control signals on each port
- ♦ Available in a 256-ball Ball Grid Array, 208-pin Plastic Quad Flatpack and 208-ball fine pitch Ball Grid Array.
- ♦ Industrial temperature range ($-40^{\circ}C$ to $+85^{\circ}C$) is available for selected speeds
- ♦ Green parts available, see ordering information

Functional Block Diagram



NOTES:

1. Address A17x is a NC for IDT70T659.
2. $\overline{BUSY}$ is an input as a Slave ($\overline{M/\overline{S}} = V_{IL}$) and an output when it is a Master ($\overline{M/\overline{S}} = V_{IH}$).
3. $\overline{BUSY}$ and $\overline{INT}$ are non-tri-state totem-pole outputs (push-pull).
4. The sleep mode pin shuts off all dynamic inputs, except JTAG inputs, when asserted. OPTx, $\overline{INTx}$, $\overline{M/\overline{S}}$ and the sleep mode pins themselves (ZZx) are not affected during sleep mode.

4869 drw 01

NOVEMBER 2017

Description

The IDT70T651/9 is a high-speed 256/128K x 36 Asynchronous Dual-Port Static RAM. The IDT70T651/9 is designed to be used as a stand-alone 9216/4608K-bit Dual-Port RAM or as a combination MASTER/SLAVE Dual-Port RAM for 72-bit-or-more word system. Using the IDT MASTER/SLAVE Dual-Port RAM approach in 72-bit or wider memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

This device provides two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down

feature controlled by the chip enables (either $\overline{CE_0}$ or CE_1) permit the on-chip circuitry of each port to enter a very low standby power mode.

The IDT70T651/9 has a RapidWrite Mode which allows the designer to perform back-to-back write operations without pulsing the $R/\overline{W}$ input each cycle. This is especially significant at the 10ns cycle time of the IDT70T651/9, easing design considerations at these high performance levels.

The 70T651/9 can support an operating voltage of either 3.3V or 2.5V on one or both ports, controlled by the OPT pins. The power supply for the core of the device (V_{DD}) is at 2.5V.

Pin Configuration^(1,2,3)

70T651/9BC

BC-256^(5,6)256-Pin BGA
Top View

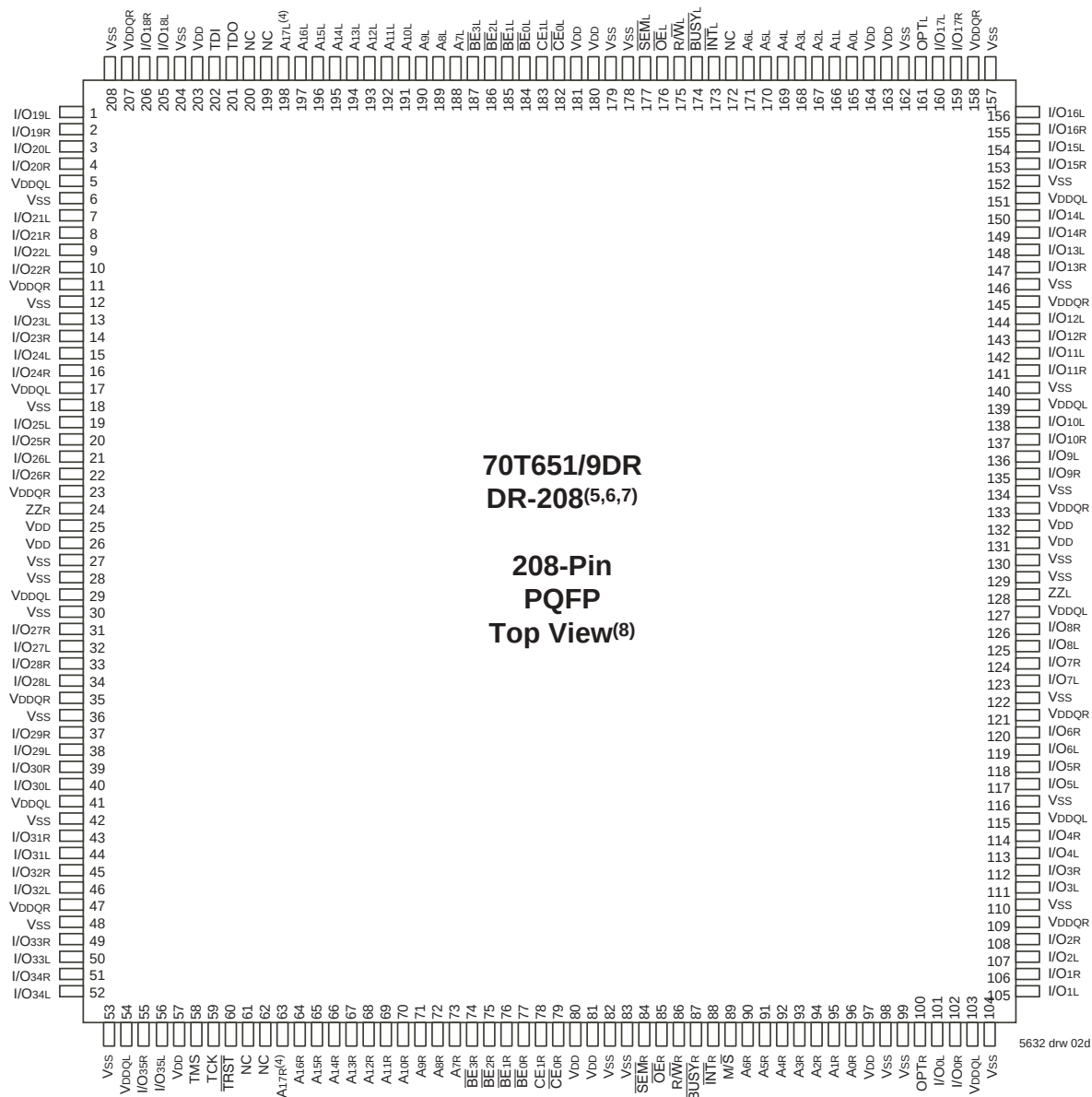
A1 NC	A2 TDI	A3 NC	A4 A17L ⁽⁴⁾	A5 A14L	A6 A11L	A7 A8L	A8 BE ₂ L	A9 CE ₁ L	A10 OE _L	A11 INT _L	A12 A5L	A13 A2L	A14 A0L	A15 NC	A16 NC
B1 I/O ₁₈ L	B2 NC	B3 TDO	B4 NC	B5 A15L	B6 A12L	B7 A9L	B8 BE ₃ L	B9 CE ₀ L	B10 R/W _L	B11 NC	B12 A4L	B13 A1L	B14 NC	B15 I/O ₁₇ L	B16 NC
C1 I/O ₁₈ R	C2 I/O ₁₉ L	C3 VSS	C4 A16L	C5 A13L	C6 A10L	C7 A7L	C8 BE ₁ L	C9 BE ₀ L	C10 SE _M L	C11 BUSY _L	C12 A6L	C13 A3L	C14 OPT _L	C15 I/O ₁₇ R	C16 I/O ₁₆ L
D1 I/O ₂₀ R	D2 I/O ₁₉ R	D3 I/O ₂₀ L	D4 VDD	D5 VDDQL	D6 VDDQL	D7 VDDQR	D8 VDDQR	D9 VDDQL	D10 VDDQL	D11 VDDQR	D12 VDDQR	D13 VDD	D14 I/O ₁₅ R	D15 I/O ₁₅ L	D16 I/O ₁₆ R
E1 I/O ₂₁ R	E2 I/O ₂₁ L	E3 I/O ₂₂ L	E4 VDDQL	E5 VDD	E6 VDD	E7 VSS	E8 VSS	E9 VSS	E10 VSS	E11 VDD	E12 VDD	E13 VDDQR	E14 I/O ₁₃ L	E15 I/O ₁₄ L	E16 I/O ₁₄ R
F1 I/O ₂₃ L	F2 I/O ₂₂ R	F3 I/O ₂₃ R	F4 VDDQL	F5 VDD	F6 NC	F7 VSS	F8 VSS	F9 VSS	F10 VSS	F11 VSS	F12 VDD	F13 VDDQR	F14 I/O ₁₂ R	F15 I/O ₁₃ R	F16 I/O ₁₂ L
G1 I/O ₂₄ R	G2 I/O ₂₄ L	G3 I/O ₂₅ L	G4 VDDQR	G5 VSS	G6 VSS	G7 VSS	G8 VSS	G9 VSS	G10 VSS	G11 VSS	G12 VSS	G13 VDDQL	G14 I/O ₁₀ L	G15 I/O ₁₁ L	G16 I/O ₁₁ R
H1 I/O ₂₆ L	H2 I/O ₂₅ R	H3 I/O ₂₆ R	H4 VDDQR	H5 VSS	H6 VSS	H7 VSS	H8 VSS	H9 VSS	H10 VSS	H11 VSS	H12 VSS	H13 VDDQL	H14 I/O ₉ R	H15 I/O ₉ L	H16 I/O ₁₀ R
J1 I/O ₂₇ L	J2 I/O ₂₈ R	J3 I/O ₂₇ R	J4 VDDQL	J5 ZZR	J6 VSS	J7 VSS	J8 VSS	J9 VSS	J10 VSS	J11 VSS	J12 ZZL	J13 VDDQR	J14 I/O ₈ R	J15 I/O ₇ R	J16 I/O ₈ L
K1 I/O ₂₉ R	K2 I/O ₂₉ L	K3 I/O ₂₈ L	K4 VDDQL	K5 VSS	K6 VSS	K7 VSS	K8 VSS	K9 VSS	K10 VSS	K11 VSS	K12 VSS	K13 VDDQR	K14 I/O ₆ R	K15 I/O ₆ L	K16 I/O ₇ L
L1 I/O ₃₀ L	L2 I/O ₃₁ R	L3 I/O ₃₀ R	L4 VDDQR	L5 VDD	L6 NC	L7 VSS	L8 VSS	L9 VSS	L10 VSS	L11 VSS	L12 VDD	L13 VDDQL	L14 I/O ₅ L	L15 I/O ₄ R	L16 I/O ₅ R
M1 I/O ₃₂ R	M2 I/O ₃₂ L	M3 I/O ₃₁ L	M4 VDDQR	M5 VDD	M6 VDD	M7 VSS	M8 VSS	M9 VSS	M10 VSS	M11 VDD	M12 VDD	M13 VDDQL	M14 I/O ₃ R	M15 I/O ₃ L	M16 I/O ₄ L
N1 I/O ₃₃ L	N2 I/O ₃₄ R	N3 I/O ₃₃ R	N4 VDD	N5 VDDQR	N6 VDDQR	N7 VDDQL	N8 VDDQL	N9 VDDQR	N10 VDDQR	N11 VDDQL	N12 VDDQL	N13 VDD	N14 I/O ₂ L	N15 I/O ₁ R	N16 I/O ₂ R
P1 I/O ₃₅ R	P2 I/O ₃₄ L	P3 TMS	P4 A16R	P5 A13R	P6 A10R	P7 A7R	P8 BE ₁ R	P9 BE ₀ R	P10 SE _M R	P11 BUSY _R	P12 A6R	P13 A3R	P14 I/O ₀ L	P15 I/O ₀ R	P16 I/O ₁ L
R1 I/O ₃₅ L	R2 NC	R3 TRST	R4 NC	R5 A15R	R6 A12R	R7 A9R	R8 BE ₃ R	R9 CE ₀ R	R10 R/W _R	R11 M/S	R12 A4R	R13 A1R	R14 OPT _R	R15 NC	R16 NC
T1 NC	T2 TCK	T3 NC	T4 A17R ⁽⁴⁾	T5 A14R	T6 A11R	T7 A8R	T8 BE ₂ R	T9 CE ₁ R	T10 OE _R	T11 INT _R	T12 A5R	T13 A2R	T14 A0R	T15 NC	T16 NC

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NOTES:

1. All VDD pins must be connected to 2.5V power supply.
2. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VDD (2.5V), and 2.5V if OPT pin for that port is set to VSS (0V).
3. All VSS pins must be connected to ground supply.
4. A17x is a NC for IDT70T659.
5. Package body is approximately 17mm x 17mm x 1.4mm, with 1.0mm ball-pitch.
6. This package code is used to reference the package diagram.

Pin Configurations^(1,2,3) (con't.)



NOTES:

1. All VDD pins must be connected to 2.5V power supply.
2. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VDD (2.5V) and 2.5V if OPT pin for that port is set to VSS (0V).
3. All VSS pins must be connected to ground.
4. A17x is a NC for IDT70T659.
5. Package body is approximately 28mm x 28mm x 3.5mm.
6. This package code is used to reference the package diagram.
7. 10ns Industrial speed grade is not available in the DR-208 package.
8. This text does not indicate orientation of the actual part-marking.

Pin Configurations^(1,2,3)(con't.)

	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17		
A	I/O _{19L}	I/O _{18L}	V _{SS}	TDO	NC	A _{16L}	A _{12L}	A _{8L}	$\overline{\text{BE}}_{1L}$	V _{DD}	$\overline{\text{SE}}_{ML}$	$\overline{\text{INT}}_L$	A _{4L}	A _{0L}	OPT _L	I/O _{17L}	V _{SS}	A	
B	I/O _{20R}	V _{SS}	I/O _{18R}	TDI	A _{17L} ⁽⁴⁾	A _{13L}	A _{9L}	$\overline{\text{BE}}_{2L}$	$\overline{\text{CE}}_{0L}$	V _{SS}	$\overline{\text{BUSY}}_L$	A _{5L}	A _{1L}	V _{SS}	V _{DDQR}	I/O _{16L}	I/O _{15R}	B	
C	V _{DDQL}	I/O _{19R}	V _{DDQR}	V _{DD}	NC	A _{14L}	A _{10L}	$\overline{\text{BE}}_{3L}$	CE _{1L}	V _{SS}	R/ $\overline{\text{W}}_L$	A _{6L}	A _{2L}	V _{DD}	I/O _{16R}	I/O _{15L}	V _{SS}	C	
D	I/O _{22L}	V _{SS}	I/O _{21L}	I/O _{20L}	A _{15L}	A _{11L}	A _{7L}	$\overline{\text{BE}}_{0L}$	V _{DD}	$\overline{\text{OE}}_L$	NC	A _{3L}	V _{DD}	I/O _{17R}	V _{DDQL}	I/O _{14L}	I/O _{14R}	D	
E	I/O _{23L}	I/O _{22R}	V _{DDQR}	I/O _{21R}	70T651/9BF BF-208^(5,6) 208-Ball fpBGA Top View⁽⁷⁾										I/O _{12L}	I/O _{13R}	V _{SS}	I/O _{13L}	E
F	V _{DDQL}	I/O _{23R}	I/O _{24L}	V _{SS}											V _{SS}	I/O _{12R}	I/O _{11L}	V _{DDQR}	F
G	I/O _{26L}	V _{SS}	I/O _{25L}	I/O _{24R}											I/O _{9L}	V _{DDQL}	I/O _{10L}	I/O _{11R}	G
H	V _{DD}	I/O _{26R}	V _{DDQR}	I/O _{25R}											V _{DD}	I/O _{9R}	V _{SS}	I/O _{10R}	H
J	V _{DDQL}	V _{DD}	V _{SS}	ZZ _R											ZZ _L	V _{DD}	V _{SS}	V _{DDQR}	J
K	I/O _{28R}	V _{SS}	I/O _{27R}	V _{SS}											I/O _{7R}	V _{DDQL}	I/O _{8R}	V _{SS}	K
L	I/O _{29R}	I/O _{28L}	V _{DDQR}	I/O _{27L}											I/O _{6R}	I/O _{7L}	V _{SS}	I/O _{8L}	L
M	V _{DDQL}	I/O _{29L}	I/O _{30R}	V _{SS}											V _{SS}	I/O _{6L}	I/O _{5R}	V _{DDQR}	M
N	I/O _{31L}	V _{SS}	I/O _{31R}	I/O _{30L}											I/O _{3R}	V _{DDQL}	I/O _{4R}	I/O _{5L}	N
P	I/O _{32R}	I/O _{32L}	V _{DDQR}	I/O _{35R}	$\overline{\text{TR}}_{ST}$	A _{16R}	A _{12R}	A _{8R}	$\overline{\text{BE}}_{1R}$	V _{DD}	$\overline{\text{SE}}_{MR}$	$\overline{\text{INT}}_R$	A _{4R}	I/O _{2L}	I/O _{3L}	V _{SS}	I/O _{4L}	P	
R	V _{SS}	I/O _{33L}	I/O _{34R}	TCK	A _{17R} ⁽⁴⁾	A _{13R}	A _{9R}	$\overline{\text{BE}}_{2R}$	$\overline{\text{CE}}_{0R}$	V _{SS}	$\overline{\text{BUSY}}_R$	A _{5R}	A _{1R}	V _{SS}	V _{DDQL}	I/O _{1R}	V _{DDQR}	R	
T	I/O _{33R}	I/O _{34L}	V _{DDQL}	TMS	NC	A _{14R}	A _{10R}	$\overline{\text{BE}}_{3R}$	CE _{1R}	V _{SS}	R/ $\overline{\text{W}}_R$	A _{6R}	A _{2R}	V _{SS}	I/O _{0R}	V _{SS}	I/O _{2R}	T	
U	V _{SS}	I/O _{35L}	V _{DD}	NC	A _{15R}	A _{11R}	A _{7R}	$\overline{\text{BE}}_{0R}$	V _{DD}	$\overline{\text{OE}}_R$	M/ $\overline{\text{S}}$	A _{3R}	A _{0R}	V _{DD}	OPT _R	I/O _{0L}	I/O _{1L}	U	

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NOTES:

1. All V_{DD} pins must be connected to 2.5V power supply.
2. All V_{DDQ} pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to V_{DD} (2.5V) and 2.5V if OPT pin for that port is set to V_{SS} (0V).
3. All V_{SS} pins must be connected to ground.
4. A_{17x} is a NC for IDT70T659.
5. Package body is approximately 15mm x 15mm x 1.4mm with 0.8mm ball pitch.
6. This package code is used to reference the package diagram.
7. This text does not indicate orientation of the actual part-marking.

Pin Names

Left Port	Right Port	Names
$\overline{CE}_{0L}$, CE_{1L}	$\overline{CE}_{0R}$, CE_{1R}	Chip Enables (Input)
$R/\overline{W}_L$	$R/\overline{W}_R$	Read/Write Enable (Input)
$\overline{OE}_L$	$\overline{OE}_R$	Output Enable (Input)
A_{0L} - $A_{17L}^{(1)}$	A_{0R} - $A_{17R}^{(1)}$	Address (Input)
I/O_{0L} - I/O_{35L}	I/O_{0R} - I/O_{35R}	Data Input/Output
$\overline{SEM}_L$	$\overline{SEM}_R$	Semaphore Enable (Input)
$\overline{INT}_L$	$\overline{INT}_R$	Interrupt Flag (Output)
$\overline{BUSY}_L$	$\overline{BUSY}_R$	Busy Flag (Output)
$\overline{BE}_{0L}$ - $\overline{BE}_{3L}$	$\overline{BE}_{0R}$ - $\overline{BE}_{3R}$	Byte Enables (9-bit bytes) (Input)
V_{DDQL}	V_{DDQR}	Power (I/O Bus) (3.3V or 2.5V) ⁽²⁾ (Input)
OPT_L	OPT_R	Option for selecting $V_{DDQX}^{(2,3)}$ (Input)
ZZ_L	ZZ_R	Sleep Mode Pin ⁽⁴⁾ (Input)
$M/\overline{S}$		Master or Slave Select (Input) ⁽⁵⁾
V_{DD}		Power (2.5V) ⁽²⁾ (Input)
V_{SS}		Ground (0V) (Input)
TDI		Test Data Input
TDO		Test Data Output
TCK		Test Logic Clock (10MHz) (Input)
TMS		Test Mode Select (Input)
$\overline{TRST}$		Reset (Initialize TAP Controller) (Input)

5632 tbl 01

NOTES:

1. Address A_{17x} is a NC for IDT70T659.
2. V_{DD} , OPT_x , and V_{DDQX} must be set to appropriate operating levels prior to applying inputs on I/O_x .
3. OPT_x selects the operating voltage levels for the I/O s and controls on that port. If OPT_x is set to V_{DD} (2.5V), then that port's I/O s and controls will operate at 3.3V levels and V_{DDQX} must be supplied at 3.3V. If OPT_x is set to V_{SS} (0V), then that port's I/O s and controls will operate at 2.5V levels and V_{DDQX} must be supplied at 2.5V. The OPT pins are independent of one another—both ports can operate at 3.3V levels, both can operate at 2.5V levels, or either can operate at 3.3V with the other at 2.5V.
4. The sleep mode pin shuts off all dynamic inputs, except JTAG inputs, when asserted. OPT_x , $\overline{INT}_x$, $M/\overline{S}$ and the sleep mode pins themselves (ZZ_x) are not affected during sleep mode. It is recommended that boundary scan not be operated during sleep mode.
5. $\overline{BUSY}$ is an input as a Slave ($M/\overline{S}=V_{IL}$) and an output when it is a Master ($M/\overline{S}=V_{IH}$).

Truth Table I—Read/Write and Enable Control^(1,2)

$\overline{OE}$	$\overline{SEM}$	$\overline{CE}_0$	CE_1	$\overline{BE}_3$	$\overline{BE}_2$	$\overline{BE}_1$	$\overline{BE}_0$	R/W	ZZ	Byte 3 I/O ₂₇₋₃₅	Byte 2 I/O ₁₈₋₂₆	Byte 1 I/O ₉₋₁₇	Byte 0 I/O ₀₋₈	MODE
X	H	H	X	X	X	X	X	X	L	High-Z	High-Z	High-Z	High-Z	Deselected—Power Down
X	H	X	L	X	X	X	X	X	L	High-Z	High-Z	High-Z	High-Z	Deselected—Power Down
X	H	L	H	H	H	H	H	X	L	High-Z	High-Z	High-Z	High-Z	All Bytes Deselected
X	H	L	H	H	H	H	L	L	L	High-Z	High-Z	High-Z	DIN	Write to Byte 0 Only
X	H	L	H	H	H	L	H	L	L	High-Z	High-Z	DIN	High-Z	Write to Byte 1 Only
X	H	L	H	H	L	H	H	L	L	High-Z	DIN	High-Z	High-Z	Write to Byte 2 Only
X	H	L	H	L	H	H	H	L	L	DIN	High-Z	High-Z	High-Z	Write to Byte 3 Only
X	H	L	H	H	H	L	L	L	L	High-Z	High-Z	DIN	DIN	Write to Lower 2 Bytes Only
X	H	L	H	L	L	H	H	L	L	DIN	DIN	High-Z	High-Z	Write to Upper 2 bytes Only
X	H	L	H	L	L	L	L	L	L	DIN	DIN	DIN	DIN	Write to All Bytes
L	H	L	H	H	H	H	L	H	L	High-Z	High-Z	High-Z	DOUT	Read Byte 0 Only
L	H	L	H	H	H	L	H	H	L	High-Z	High-Z	DOUT	High-Z	Read Byte 1 Only
L	H	L	H	H	L	H	H	H	L	High-Z	DOUT	High-Z	High-Z	Read Byte 2 Only
L	H	L	H	L	H	H	H	H	L	DOUT	High-Z	High-Z	High-Z	Read Byte 3 Only
L	H	L	H	H	H	L	L	H	L	High-Z	High-Z	DOUT	DOUT	Read Lower 2 Bytes Only
L	H	L	H	L	L	H	H	H	L	DOUT	DOUT	High-Z	High-Z	Read Upper 2 Bytes Only
L	H	L	H	L	L	L	L	H	L	DOUT	DOUT	DOUT	DOUT	Read All Bytes
H	H	L	H	L	L	L	L	X	L	High-Z	High-Z	High-Z	High-Z	Outputs Disabled
X	X	X	X	X	X	X	X	X	H	High-Z	High-Z	High-Z	High-Z	High-Z Sleep Mode

NOTES:

- "H" = V_{IH} , "L" = V_{IL} , "X" = Don't Care.
- It is possible to read or write any combination of bytes during a given access. A few representative samples have been illustrated here.

5632 tbl 02

Truth Table II – Semaphore Read/Write Control⁽¹⁾

Inputs ⁽²⁾								Outputs		Mode
$\overline{CE}^{(2)}$	R/W	$\overline{OE}$	$\overline{BE}_3$	$\overline{BE}_2$	$\overline{BE}_1$	$\overline{BE}_0$	$\overline{SEM}$	I/O ₁₋₃₅	I/O ₀	
H	H	L	L	L	L	L	L	DATA _{OUT}	DATA _{OUT}	Read Data in Semaphore Flag ⁽³⁾
H	↑	X	X	X	X	L	L	X	DATA _{IN}	Write I/O ₀ into Semaphore Flag
L	X	X	X	X	X	X	L	—	—	Not Allowed

NOTES:

- There are eight semaphore flags written to I/O₀ and read from all the I/Os (I/O₀-I/O₃₅). These eight semaphore flags are addressed by A₀-A₂.
- $\overline{CE}$ = L occurs when $\overline{CE}_0$ = V_{IL} and CE_1 = V_{IH} . $\overline{CE}$ = H when $\overline{CE}_0$ = V_{IH} and/or CE_1 = V_{IL} .
- Each byte is controlled by the respective $\overline{BE}_n$. To read data $\overline{BE}_n$ = V_{IL} .

5632 tbl 03

Recommended Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	V _{DD}
Commercial	0°C to +70°C	0V	2.5V $\pm$ 100mV
Industrial	-40°C to +85°C	0V	2.5V $\pm$ 100mV

5632 tbl 04

NOTE:

1. This is the parameter TA. This is the "instant on" case temperature.

Capacitance⁽¹⁾

(TA = +25°C, F = 1.0MHz) PQFP ONLY

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 3dV	8	pF
C _{OUT} ⁽³⁾	Output Capacitance	V _{OUT} = 3dV	10.5	pF

5632 tbl 08

NOTES:

1. These parameters are determined by device characterization, but are not production tested.
2. 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
3. C_{OUT} also references C_{I/O}.

Absolute Maximum Ratings⁽¹⁾

Symbol	Rating	Commercial & Industrial	Unit
V _{TERM} (V _{DD})	V _{DD} Terminal Voltage with Respect to GND	-0.5 to 3.6	V
V _{TERM} ⁽²⁾ (V _{DDQ})	V _{DDQ} Terminal Voltage with Respect to GND	-0.3 to V _{DDQ} + 0.3	V
V _{TERM} ⁽²⁾ (INPUTS and I/O's)	Input and I/O Terminal Voltage with Respect to GND	-0.3 to V _{DDQ} + 0.3	V
T _{BIAS} ⁽³⁾	Temperature Under Bias	-55 to +125	°C
T _{STG}	Storage Temperature	-65 to +150	°C
T _{JN}	Junction Temperature	+150	°C
I _{OUT} (For V _{DDQ} = 3.3V)	DC Output Current	50	mA
I _{OUT} (For V _{DDQ} = 2.5V)	DC Output Current	40	mA

5632 tbl 07

NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. This is a steady-state DC parameter that applies after the power supply has reached its nominal operating value. Power sequencing is not necessary; however, the voltage on any Input or I/O pin cannot exceed V_{DDQ} during power supply ramp up.
3. Ambient Temperature under DC Bias. No AC Conditions. Chip Deselected.

Recommended DC Operating Conditions with V_{DDQ} at 2.5V

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{DD}	Core Supply Voltage	2.4	2.5	2.6	V
V _{DDQ}	I/O Supply Voltage ⁽³⁾	2.4	2.5	2.6	V
V _{SS}	Ground	0	0	0	V
V _{IH}	Input High Voltage (Address, Control & Data I/O Inputs) ⁽³⁾	1.7	—	V _{DDQ} + 100mV ⁽²⁾	V
V _{IH}	Input High Voltage - JTAG	1.7	—	V _{DD} + 100mV ⁽²⁾	V
V _{IH}	Input High Voltage - ZZ, OPT, M/S	V _{DD} - 0.2V	—	V _{DD} + 100mV ⁽²⁾	V
V _{IL}	Input Low Voltage	-0.3 ⁽¹⁾	—	0.7	V
V _{IL}	Input Low Voltage - ZZ, OPT, M/S	-0.3 ⁽¹⁾	—	0.2	V

5632 tbl 05

NOTES:

1. V_{IL} (min.) = -1.0V for pulse width less than trc/2 or 5ns, whichever is less.
2. V_{IH} (max.) = V_{DDQ} + 1.0V for pulse width less than trc/2 or 5ns, whichever is less.
3. To select operation at 2.5V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to V_{SS}(0V), and V_{DDQX} for that port must be supplied as indicated above.

Recommended DC Operating Conditions with V_{DDQ} at 3.3V

Symbol	Parameter	Min.	Typ.	Max.	Unit
V _{DD}	Core Supply Voltage	2.4	2.5	2.6	V
V _{DDQ}	I/O Supply Voltage ⁽³⁾	3.15	3.3	3.45	V
V _{SS}	Ground	0	0	0	V
V _{IH}	Input High Voltage (Address, Control & Data I/O Inputs) ⁽³⁾	2.0	—	V _{DDQ} + 150mV ⁽²⁾	V
V _{IH}	Input High Voltage - JTAG	1.7	—	V _{DD} + 100mV ⁽²⁾	V
V _{IH}	Input High Voltage - ZZ, OPT, M/S	V _{DD} - 0.2V	—	V _{DD} + 100mV ⁽²⁾	V
V _{IL}	Input Low Voltage	-0.3 ⁽¹⁾	—	0.8	V
V _{IL}	Input Low Voltage - ZZ, OPT, M/S	-0.3 ⁽¹⁾	—	0.2	V

5632 tbl 06

NOTES:

1. V_{IL} (min.) = -1.0V for pulse width less than trc/2 or 5ns, whichever is less.
2. V_{IH} (max.) = V_{DDQ} + 1.0V for pulse width less than trc/2 or 5ns, whichever is less.
3. To select operation at 3.3V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to V_{DD} (2.5V), and V_{DDQX} for that port must be supplied as indicated above.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range ($V_{DD} = 2.5V \pm 100mV$)

Symbol	Parameter	Test Conditions	70T651/9S		Unit
			Min.	Max.	
$ I_{LI} $	Input Leakage Current ⁽¹⁾	$V_{DDQ} = \text{Max.}, V_{IN} = 0V \text{ to } V_{DDQ}$	—	10	μA
$ I_{LI} $	JTAG & ZZ Input Leakage Current ^(1,2)	$V_{DD} = \text{Max.}, V_{IN} = 0V \text{ to } V_{DD}$	—	± 30	μA
$ I_{LO} $	Output Leakage Current ^(1,3)	$\overline{CE}_0 = V_{IH} \text{ or } CE_1 = V_{IL}, V_{OUT} = 0V \text{ to } V_{DDQ}$	—	10	μA
$V_{OL} (3.3V)$	Output Low Voltage ⁽¹⁾	$I_{OL} = +4mA, V_{DDQ} = \text{Min.}$	—	0.4	V
$V_{OH} (3.3V)$	Output High Voltage ⁽¹⁾	$I_{OH} = -4mA, V_{DDQ} = \text{Min.}$	2.4	—	V
$V_{OL} (2.5V)$	Output Low Voltage ⁽¹⁾	$I_{OL} = +2mA, V_{DDQ} = \text{Min.}$	—	0.4	V
$V_{OH} (2.5V)$	Output High Voltage ⁽¹⁾	$I_{OH} = -2mA, V_{DDQ} = \text{Min.}$	2.0	—	V

5632 tbl 09

NOTES:

- V_{DDQ} is selectable (3.3V/2.5V) via OPT pins. Refer to page 6 for details.
- Applicable only for TMS, TDI and TRST inputs.
- Outputs tested in tri-state mode.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range⁽³⁾ ($V_{DD} = 2.5V \pm 100mV$)

Symbol	Parameter	Test Condition	Version	70T651/9S10 Com'l & Ind ⁽⁷⁾		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only		Unit
				Typ. ⁽⁴⁾	Max.	Typ. ⁽⁴⁾	Max.	Typ. ⁽⁴⁾	Max.	
IDD	Dynamic Operating Current (Both Ports Active)	$\overline{CE}_L \text{ and } \overline{CE}_R = V_{IL}$, Outputs Disabled $f = f_{MAX}^{(1)}$	COM'L S	300	405	300	355	225	305	mA
			IND S	300	445	300	395	—	—	
ISB1 ⁽⁶⁾	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L = \overline{CE}_R = V_{IH}$ $f = f_{MAX}^{(1)}$	COM'L S	90	120	75	105	60	85	mA
			IND S	90	145	75	130	—	—	
ISB2 ⁽⁶⁾	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}^*A = V_{IL} \text{ and } \overline{CE}^*B = V_{IH}^{(5)}$ Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L S	200	265	180	230	150	200	mA
			IND S	200	290	180	255	—	—	
ISB3	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports $\overline{CE}_L$ and $\overline{CE}_R \geq V_{DDQ} - 0.2V$, $V_{IN} \geq V_{DDQ} - 0.2V$ or $V_{IN} \leq 0.2V$, $f = 0^{(2)}$	COM'L S	2	10	2	10	2	10	mA
			IND S	2	20	2	20	—	—	
ISB4 ⁽⁶⁾	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}^*A \leq 0.2V$ and $\overline{CE}^*B \geq V_{DDQ} - 0.2V^{(5)}$ $V_{IN} \geq V_{DDQ} - 0.2V$ or $V_{IN} \leq 0.2V$, Active Port, Outputs Disabled, $f = f_{MAX}^{(1)}$	COM'L S	200	265	180	230	150	200	mA
			IND S	200	290	180	255	—	—	
IZZ	Sleep Mode Current (Both Ports - TTL Level Inputs)	$ZZ_L = ZZ_R = V_{IH}$ $f = f_{MAX}^{(1)}$	COM'L S	2	10	2	10	2	10	mA
			IND S	2	20	2	20	—	—	

5632 tbl 10

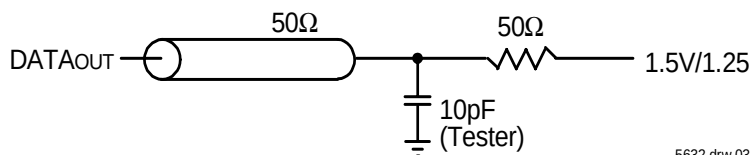
NOTES:

- At $f = f_{MAX}$, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of $1/t_{RC}$, using "ACT TEST CONDITIONS" at input levels of GND to 3.3V.
- $f = 0$ means no address or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{DD} = 3.3V$, $T_A = 25^\circ C$ for Typ, and are not production tested. $I_{DDQ}(f=0) = 100mA$ (Typ).
- $\overline{CE}_X = V_{IL}$ means $\overline{CE}_{0X} = V_{IL}$ and $CE_{1X} = V_{IH}$
 $\overline{CE}_X = V_{IH}$ means $\overline{CE}_{0X} = V_{IH}$ or $CE_{1X} = V_{IL}$
 $\overline{CE}_X \leq 0.2V$ means $\overline{CE}_{0X} \leq 0.2V$ and $CE_{1X} \geq V_{DDQ} - 0.2V$
 $\overline{CE}_X \geq V_{DDQ} - 0.2V$ means $\overline{CE}_{0X} \geq V_{DDQ} - 0.2V$ or $CE_{1X} \leq 0.2V$.
"X" represents "L" for left port or "R" for right port.
- ISB1, ISB2 and ISB4 will all reach full standby levels (ISB3) on the appropriate port(s) if ZZ_L and/or $ZZ_R = V_{IH}$.
- 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.

AC Test Conditions ($V_{DDQ} = 3.3V/2.5V$)

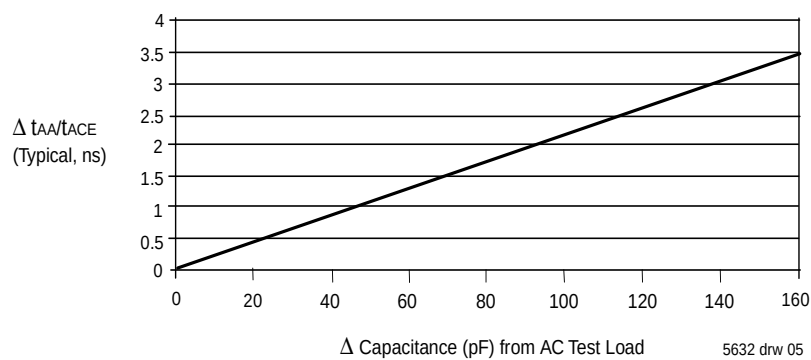
Input Pulse Levels	GND to 3.0V / GND to 2.4V
Input Rise/Fall Times	2ns Max.
Input Timing Reference Levels	1.5V/1.25V
Output Reference Levels	1.5V/1.25V
Output Load	Figure 1

5632 tbl 11



5632 drw 03

Figure 1. AC Output Test load.



5632 drw 05

Figure 3. Typical Output Derating (Lumped Capacitive Load).

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range⁽⁴⁾

Symbol	Parameter	70T651/9S10 Com'l Only		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
READ CYCLE								
tRC	Read Cycle Time	10	—	12	—	15	—	ns
tAA	Address Access Time	—	10	—	12	—	15	ns
tACE	Chip Enable Access Time ⁽³⁾	—	10	—	12	—	15	ns
tABE	Byte Enable Access Time ⁽²⁾	—	5	—	6	—	7	ns
tAOE	Output Enable Access Time	—	5	—	6	—	7	ns
tOH	Output Hold from Address Change	3	—	3	—	3	—	ns
tLZ	Output Low-Z Time ^(1,2)	0	—	0	—	0	—	ns
tHZ	Output High-Z Time ^(1,2)	0	4	0	6	0	8	ns
tPU	Chip Enable to Power Up Time ⁽²⁾	0	—	0	—	0	—	ns
tPD	Chip Disable to Power Down Time ⁽²⁾	—	8	—	8	—	12	ns
tSOP	Semaphore Flag Update Pulse ($\overline{OE}$ or $\overline{SEM}$)	—	4	—	6	—	8	ns
tsAA	Semaphore Address Access Time	2	10	2	12	2	15	ns

5632tbl 12

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽⁴⁾

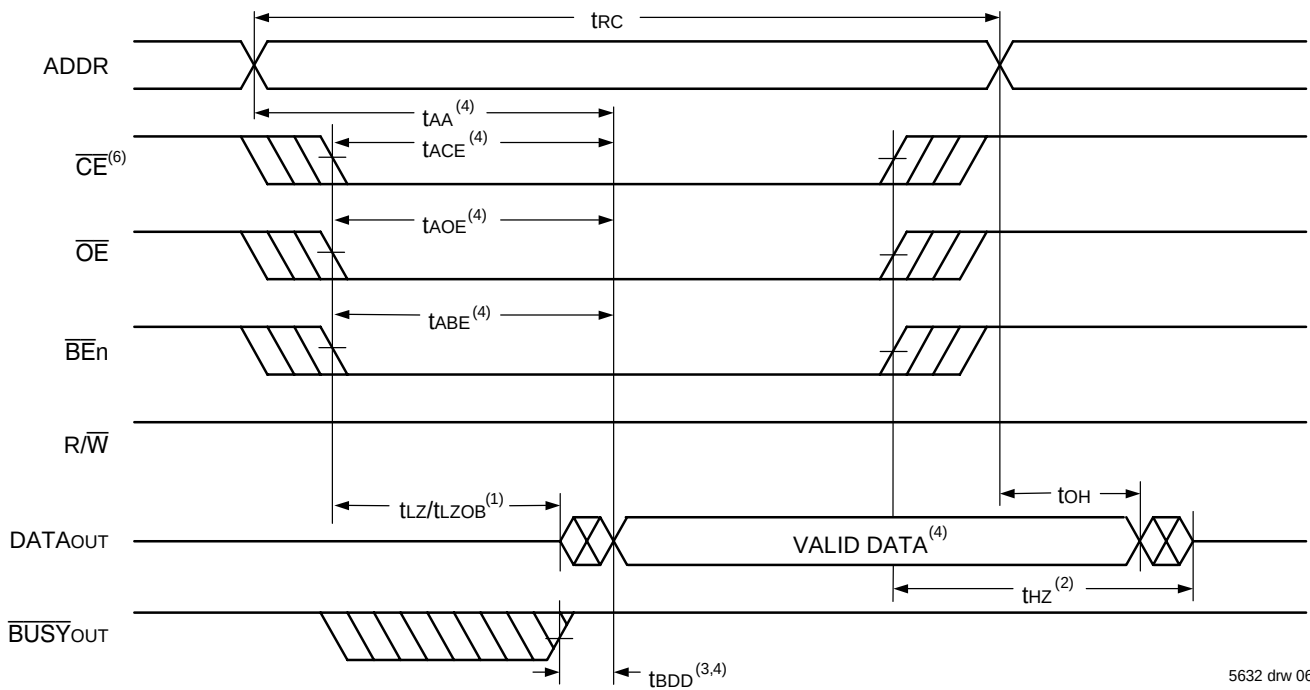
Symbol	Parameter	70T651/9S10 Com'l Only		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
WRITE CYCLE								
t _{WC}	Write Cycle Time	10	—	12	—	15	—	ns
t _{EW}	Chip Enable to End-of-Write ⁽³⁾	8	—	10	—	12	—	ns
t _{AW}	Address Valid to End-of-Write	8	—	10	—	12	—	ns
t _{AS}	Address Set-up Time ⁽³⁾	0	—	0	—	0	—	ns
t _{WP}	Write Pulse Width	8	—	10	—	12	—	ns
t _{WR}	Write Recovery Time	0	—	0	—	0	—	ns
t _{DW}	Data Valid to End-of-Write	6	—	8	—	10	—	ns
t _{DH}	Data Hold Time ⁽⁴⁾	0	—	0	—	0	—	ns
t _{WZ}	Write Enable to Output in High-Z ^(1,2)	—	4	—	6	—	8	ns
t _{OW}	Output Active from End-of-Write ^(1,2,4)	0	—	0	—	0	—	ns
t _{SWRD}	$\overline{\text{SEM}}$ Flag Write to Read Time	5	—	5	—	5	—	ns
t _{SPS}	$\overline{\text{SEM}}$ Flag Contention Window	5	—	5	—	5	—	ns

5632 tbl 13

NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with Output Test Load (Figure 1).
2. This parameter is guaranteed by device characterization, but is not production tested.
3. To access RAM, $\overline{CE} = V_{IL}$ and $\overline{SEM} = V_{IH}$. To access semaphore, $\overline{CE} = V_{IH}$ and $\overline{SEM} = V_{IL}$. Either condition must be valid for the entire t_{EW} time. $\overline{CE} = V_{IL}$ when $\overline{CE}_0 = V_{IL}$ and $\overline{CE}_1 = V_{IH}$. $\overline{CE} = V_{IH}$ when $\overline{CE}_0 = V_{IH}$ and/or $\overline{CE}_1 = V_{IL}$.
4. These values are valid regardless of the power supply level selected for I/O and control signals (3.3V/2.5V). See page 6 for details.
5. 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.

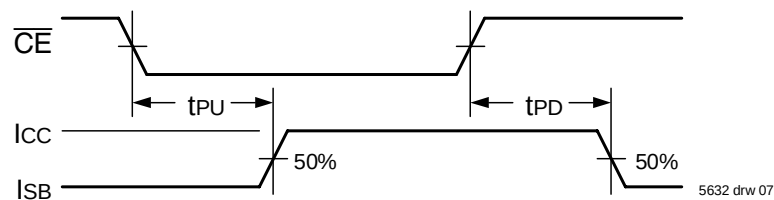
Waveform of Read Cycles⁽⁵⁾

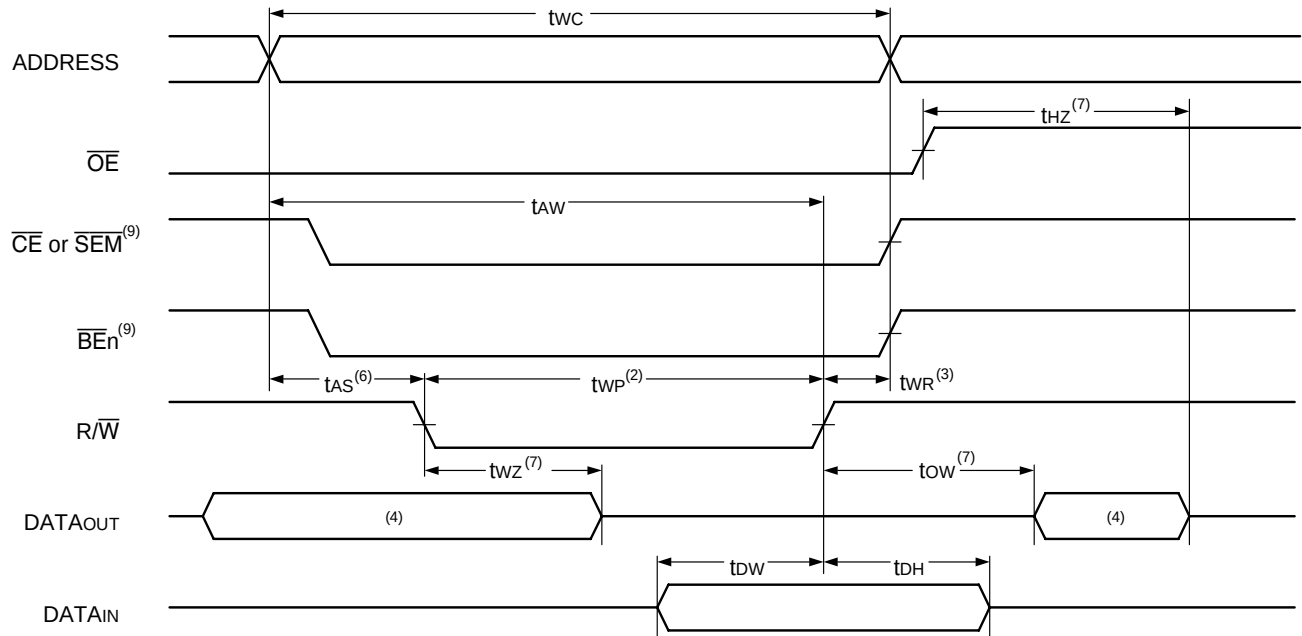


NOTES:

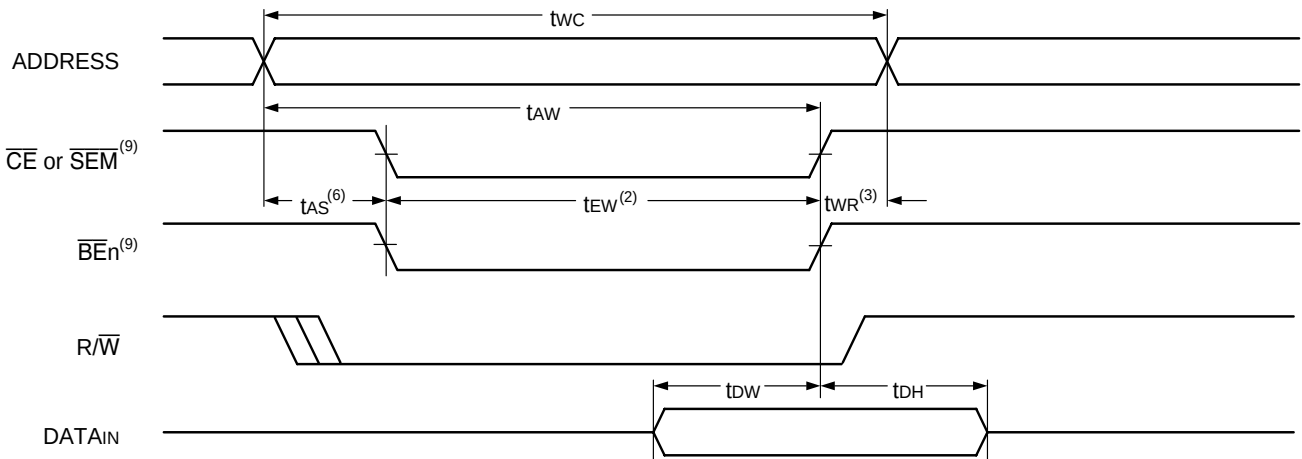
1. Timing depends on which signal is asserted last, $\overline{OE}$, $\overline{CE}$ or $\overline{BEn}$.
2. Timing depends on which signal is de-asserted first $\overline{CE}$, $\overline{OE}$ or $\overline{BEn}$.
3. t_{BDD} delay is required only in cases where the opposite port is completing a write operation to the same address location. For simultaneous read operations $\overline{BUSY}$ has no relation to valid output data.
4. Start of valid data depends on which timing becomes effective last t_{AOE} , t_{ACE} , t_{AA} , t_{ABE} or t_{BDD} .
5. $\overline{SEM} = V_{IH}$.
6. $\overline{CE} = L$ occurs when $\overline{CE0} = V_{IL}$ and $CE1 = V_{IH}$. $\overline{CE} = H$ when $\overline{CE0} = V_{IH}$ and/or $CE1 = V_{IL}$.

Timing of Power-Up Power-Down



Timing Waveform of Write Cycle No. 1, $R/\overline{W}$ Controlled Timing^(1,5,8)

5632 drw 10

Timing Waveform of Write Cycle No. 2, $\overline{CE}$ Controlled Timing^(1,5,8)

5632 drw 11

NOTES:

1. $R/\overline{W}$ or $\overline{CE}$ or $\overline{BEn}$ = V_{IH} during all address transitions for Write Cycles 1 and 2.
2. A write occurs during the overlap (t_{EW} or t_{WP}) of a $\overline{CE}$ = V_{IL} , $\overline{BEn}$ = V_{IL} , and a $R/\overline{W}$ = V_{IL} for memory array writing cycle.
3. t_{WR} is measured from the earlier of $\overline{CE}$, $\overline{BEn}$ or $R/\overline{W}$ (or $\overline{SEM}$ or $R/\overline{W}$) going HIGH to the end of write cycle.
4. During this period, the I/O pins are in the output state and input signals must not be applied.
5. If the $\overline{CE}$ or $\overline{SEM}$ = V_{IL} transition occurs simultaneously with or after the $R/\overline{W}$ = V_{IL} transition, the outputs remain in the High-impedance state.
6. Timing depends on which enable signal is asserted last, $\overline{CE}$ or $R/\overline{W}$.
7. This parameter is guaranteed by device characterization, but is not production tested. Transition is measured 0mV from steady state with the Output Test Load (Figure 1).
8. If $\overline{OE}$ = V_{IL} during $R/\overline{W}$ controlled write cycle, the write pulse width must be the larger of t_{WP} or ($t_{WZ} + t_{DW}$) to allow the I/O drivers to turn off and data to be placed on the bus for the required t_{DW} . If $\overline{OE}$ = V_{IH} during an $R/\overline{W}$ controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified t_{WP} .
9. To access RAM, $\overline{CE}$ = V_{IL} and $\overline{SEM}$ = V_{IH} . To access semaphore, $\overline{CE}$ = V_{IH} and $\overline{SEM}$ = V_{IL} . t_{EW} must be met for either condition. $\overline{CE}$ = V_{IL} when $\overline{CE}_0$ = V_{IL} and CE_1 = V_{IH} . $\overline{CE}$ = V_{IH} when $\overline{CE}_0$ = V_{IH} and/or CE_1 = V_{IL} .

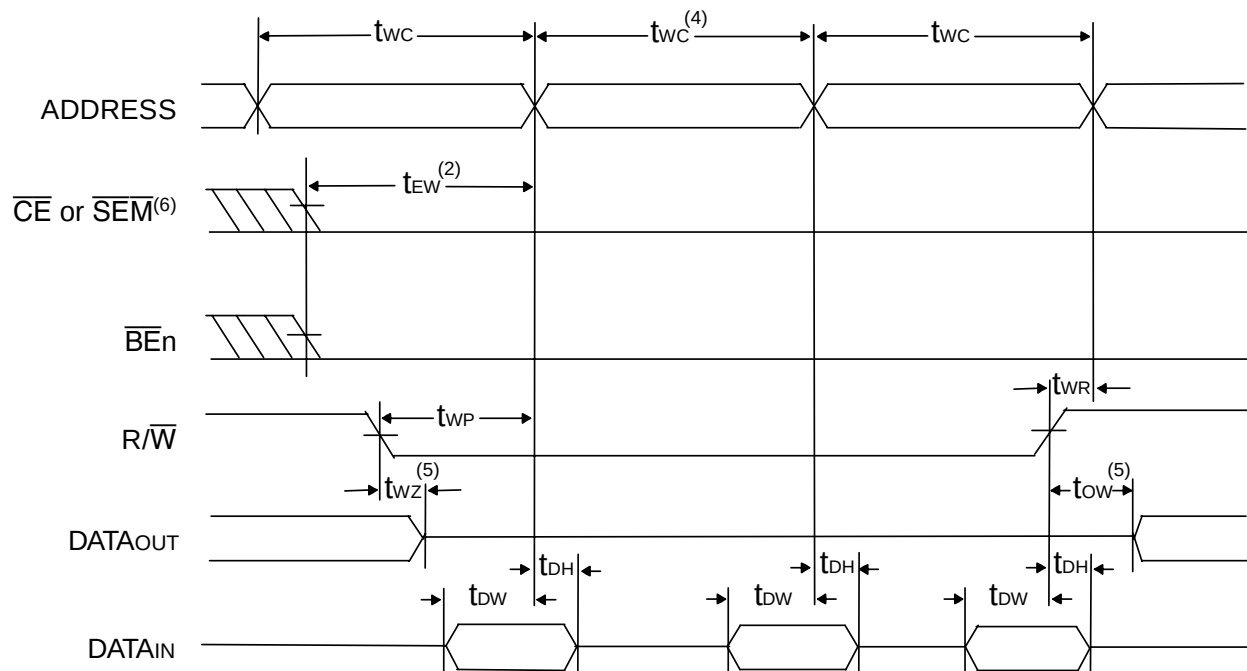
RapidWrite Mode Write Cycle

Unlike other vendors' Asynchronous Random Access Memories, the IDT70T651/9 is capable of performing multiple back-to-back write operations without having to pulse the $\overline{R/\overline{W}}$, $\overline{CE}$, or $\overline{BEn}$ signals high during address transitions. This RapidWrite Mode functionality allows the system designer to achieve optimum back-to-back write cycle performance without the difficult task of generating narrow reset pulses every cycle, simplifying system design and reducing time to market.

During this new RapidWrite Mode, the end of the write cycle is now defined by the ending address transition, instead of the $\overline{R/\overline{W}}$ or $\overline{CE}$ or $\overline{BEn}$ transition to the inactive state. $\overline{R/\overline{W}}$, $\overline{CE}$, and $\overline{BEn}$ can be held active throughout the address transition between write cycles. Care must be

taken to still meet the Write Cycle time (t_{wc}), the time in which the Address inputs must be stable. Input data setup and hold times (t_{dw} and t_{dh}) will now be referenced to the ending address transition. In this RapidWrite Mode the I/O will remain in the Input mode for the duration of the operations due to $\overline{R/\overline{W}}$ being held low. All standard Write Cycle specifications must be adhered to. However, t_{as} and t_{wr} are only applicable when switching between read and write operations. Also, there are two additional conditions on the Address Inputs that must also be met to ensure correct address controlled writes. These specifications, the Allowable Address Skew (t_{aas}) and the Address Rise/Fall time (t_{arf}), must be met to use the RapidWrite Mode. If these conditions are not met there is the potential for inadvertent write operations at random intermediate locations as the device transitions between the desired write addresses.

Timing Waveform of Write Cycle No. 3, RapidWrite Mode Write Cycle^(1,3)



5632 drw 08

NOTES:

1. $\overline{OE} = V_{IL}$ for this timing waveform as shown. $\overline{OE}$ may equal V_{IH} with same write functionality; I/O would then always be in High-Z state.
2. A write occurs during the overlap (t_{EW} or t_{WP}) of a $\overline{CE} = V_{IL}$, $\overline{BEn} = V_{IL}$, and a $\overline{R/\overline{W}} = V_{IL}$ for memory array writing cycle. The last transition LOW of $\overline{CE}$, $\overline{BEn}$, and $\overline{R/\overline{W}}$ initiates the write sequence. The first transition HIGH of $\overline{CE}$, $\overline{BEn}$, and $\overline{R/\overline{W}}$ terminates the write sequence.
3. If the $\overline{CE}$ or $\overline{SEM} = V_{IL}$ transition occurs simultaneously with or after the $\overline{R/\overline{W}} = V_{IL}$ transition, the outputs remain in the High-impedance state.
4. The timing represented in this cycle can be repeated multiple times to execute sequential RapidWrite Mode writes.
5. This parameter is guaranteed by device characterization, but is not production tested. Transition is measured 0mV from steady state with the Output Test Load (Figure 1).
6. To access RAM, $\overline{CE} = V_{IL}$ and $\overline{SEM} = V_{IH}$. To access semaphore, $\overline{CE} = V_{IH}$ and $\overline{SEM} = V_{IL}$. t_{EW} must be met for either condition. $\overline{CE} = V_{IL}$ when $\overline{CE}_0 = V_{IL}$ and $\overline{CE}_1 = V_{IH}$. $\overline{CE} = V_{IH}$ when $\overline{CE}_0 = V_{IH}$ and/or $\overline{CE}_1 = V_{IL}$.

AC Electrical Characteristics over the Operating Temperature Range and Supply Voltage Range for RapidWrite Mode Write Cycle⁽¹⁾

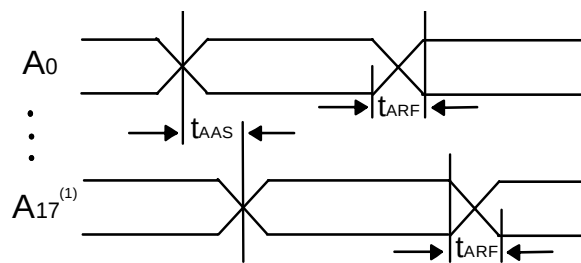
Symbol	Parameter	Min	Max	Unit
t_{AAS}	Allowable Address Skew for RapidWrite Mode	—	1	ns
t_{ARF}	Address Rise/Fall Time for RapidWrite Mode	1.5	—	V/ns

5632 tbl 14

NOTE:

- Timing applies to all speed grades when utilizing the RapidWrite Mode Write Cycle.

Timing Waveform of Address Inputs for RapidWrite Mode Write Cycle

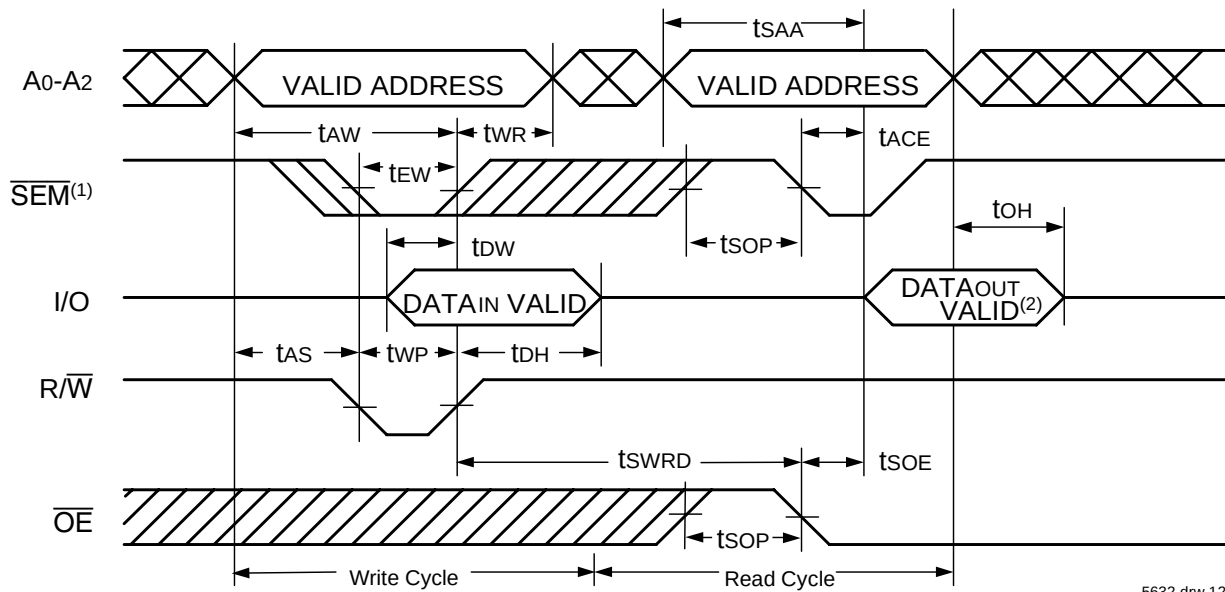


5632 drw 09

NOTE:

- A₁₆ for IDT70T659.

Timing Waveform of Semaphore Read after Write Timing, Either Side⁽¹⁾

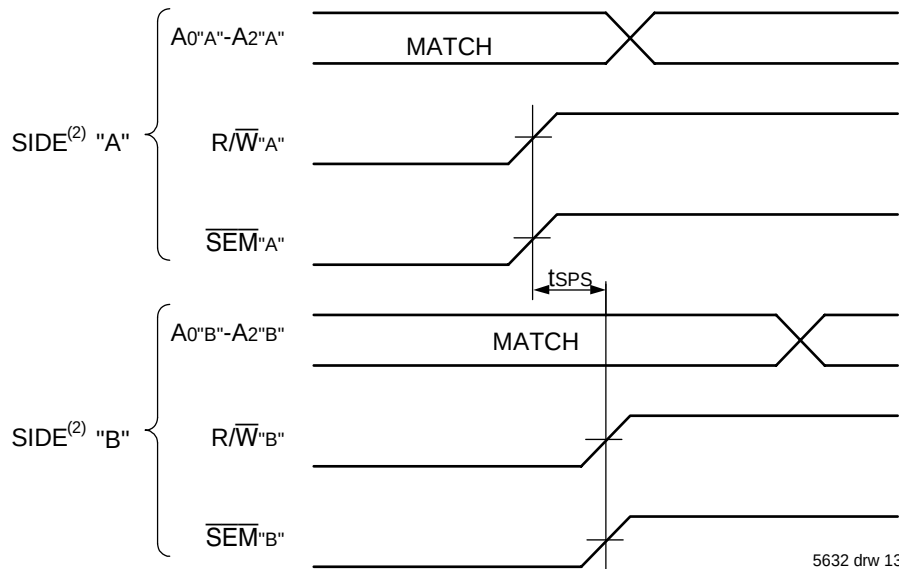


5632 drw 12

NOTES:

1. $\overline{CE}_0 = V_{IH}$ and $CE_1 = V_{IL}$ are required for the duration of both the write cycle and the read cycle waveforms shown above. Refer to Truth Table II for details and for appropriate $\overline{BEn}$ controls.
2. "DATAOUT VALID" represents all I/O's (I/O₀ - I/O₃₅) equal to the semaphore value.

Timing Waveform of Semaphore Write Contention^(1,3,4)



5632 drw 13

NOTES:

1. $DOR = DOL = V_{IL}$, $\overline{CEL} = \overline{CER} = V_{IH}$. Refer to Truth Table II for appropriate $\overline{BE}$ controls.
2. All timing is the same for left and right ports. Port "A" may be either left or right port. "B" is the opposite from port "A".
3. This parameter is measured from $R/\overline{W}$ "A" or $\overline{SEM}$ "A" going HIGH to $R/\overline{W}$ "B" or $\overline{SEM}$ "B" going HIGH.
4. If tSPS is not satisfied, the semaphore will fall positively to one side or the other, but there is no guarantee which side will be granted the semaphore flag.

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range

Symbol	Parameter	70T651/9S10 Com'l Only		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
BUSY TIMING (M/S=VIH)								
tBAA	BUSY Access Time from Address Match	—	10	—	12	—	15	ns
tBDA	BUSY Disable Time from Address Not Matched	—	10	—	12	—	15	ns
tBAC	BUSY Access Time from Chip Enable Low	—	10	—	12	—	15	ns
tBDC	BUSY Disable Time from Chip Enable High	—	10	—	12	—	15	ns
tAPS	Arbitration Priority Set-up Time ⁽²⁾	2.5	—	2.5	—	2.5	—	ns
tBDD	BUSY Disable to Valid Data ⁽³⁾	—	10	—	12	—	15	ns
tWH	Write Hold After BUSY ⁽⁵⁾	8	—	10	—	12	—	ns
BUSY TIMING (M/S=VIL)								
tWB	BUSY Input to Write ⁽⁴⁾	0	—	0	—	0	—	ns
tWH	Write Hold After BUSY ⁽⁵⁾	8	—	10	—	12	—	ns
PORT-TO-PORT DELAY TIMING								
twDD	Write Pulse to Data Delay ⁽¹⁾	—	22	—	25	—	30	ns
tDDD	Write Data Valid to Read Data Delay ⁽¹⁾	—	20	—	22	—	25	ns

5632 tbl 15b

NOTES:

- Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write with Port-to-Port Read and $\overline{BUSY}$ ($M/\bar{S} = V_{IH}$)".
- To ensure that the earlier of the two ports wins.
- tBDD is a calculated parameter and is the greater of the Max. spec, twDD – tWP (actual), or tDD – tDW (actual).
- To ensure that the write cycle is inhibited on port "B" during contention on port "A".
- To ensure that a write cycle is completed on port "B" after contention on port "A".
- 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range^(1,2,3)

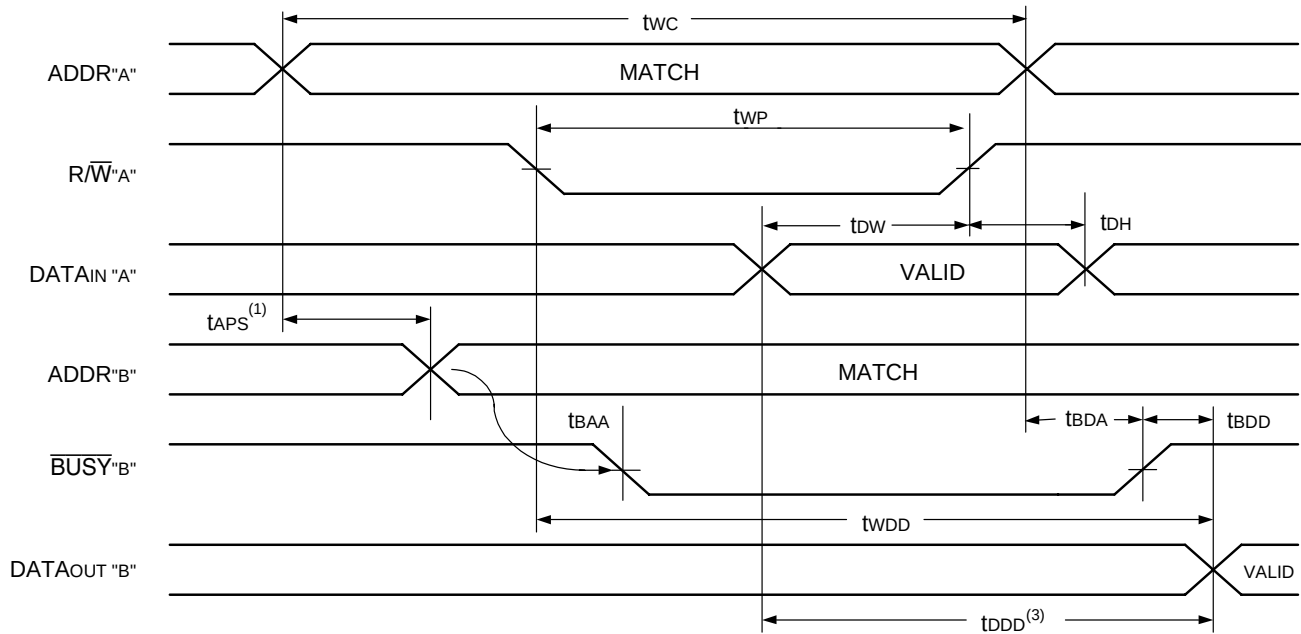
Symbol	Parameter	70T651/9S10 Com'l Only		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only	
		Min.	Max.	Min.	Max.	Min.	Max.
SLEEP MODE TIMING (ZZx=VIH)							
tzs	Sleep Mode Set Time	10	—	12	—	15	—
tzr	Sleep Mode Reset Time	10	—	12	—	15	—
tzpd	Sleep Mode Power Down Time	10	—	12	—	15	—
tzpu	Sleep Mode Power Up Time	—	0	—	0	—	0

5632 tbl 15c

NOTES:

- Timing is the same for both ports.
- The sleep mode pin shuts off all dynamic inputs, except JTAG inputs, when asserted. OPTx, $\overline{INTx}$, $M/\bar{S}$ and the sleep mode pins themselves (ZZx) are not affected during sleep mode. It is recommended that boundary scan not be operated during sleep mode.
- These values are valid regardless of the power supply level selected for I/O and control signals (3.3V/2.5V). See page 6 for details.
- 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.
- This parameter is guaranteed by device characterization, but is not production tested.

Timing Waveform of Write with Port-to-Port Read and $\overline{\text{BUSY}}$ ($\text{M}/\overline{\text{S}} = \text{V}_{\text{IH}}$)^(2,4,5)

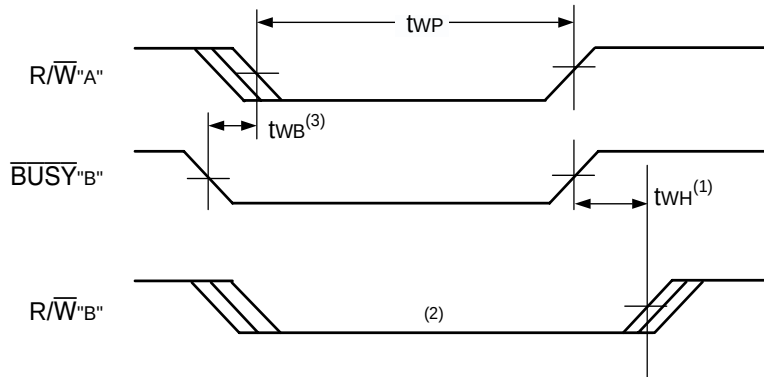


NOTES:

1. To ensure that the earlier of the two ports wins. t_{APS} is ignored for $\text{M}/\overline{\text{S}} = \text{V}_{\text{IL}}$ (SLAVE).
2. $\overline{\text{CE}}_{0\text{L}} = \overline{\text{CE}}_{0\text{R}} = \text{V}_{\text{IL}}$; $\text{CE}_{1\text{L}} = \text{CE}_{1\text{R}} = \text{V}_{\text{IH}}$.
3. $\overline{\text{OE}} = \text{V}_{\text{IL}}$ for the reading port.
4. If $\text{M}/\overline{\text{S}} = \text{V}_{\text{IL}}$ (slave), $\overline{\text{BUSY}}$ is an input. Then for this example $\overline{\text{BUSY}}_{\text{A}} = \text{V}_{\text{IH}}$ and $\overline{\text{BUSY}}_{\text{B}}$ input is shown above.
5. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

5632 drw 14

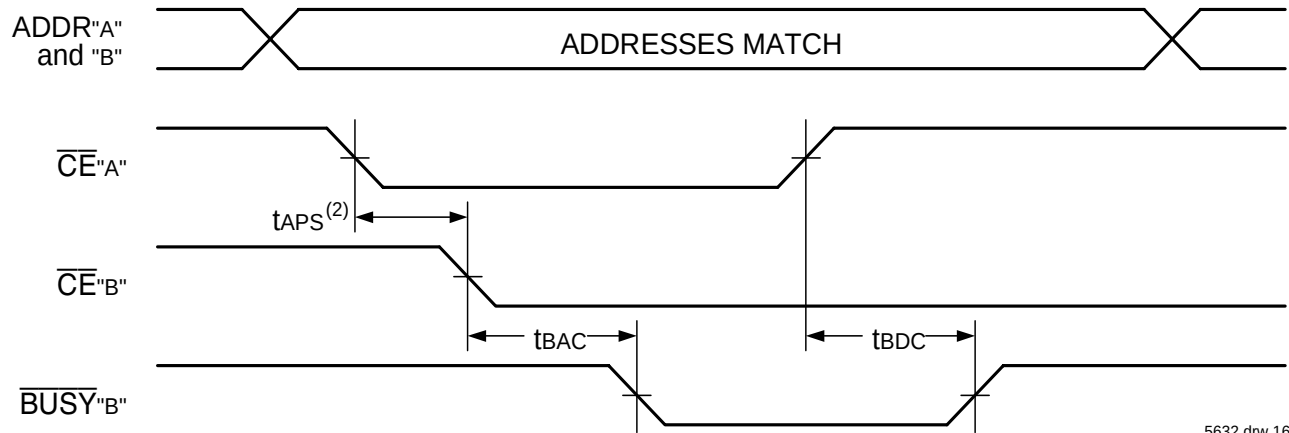
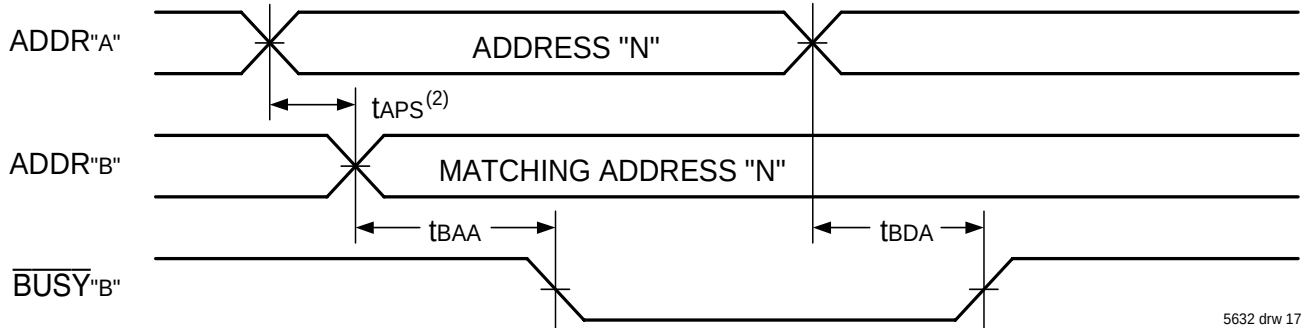
Timing Waveform of Write with $\overline{\text{BUSY}}$ ($\text{M}/\overline{\text{S}} = \text{V}_{\text{IL}}$)



NOTES:

1. t_{WH} must be met for both $\overline{\text{BUSY}}$ input (SLAVE) and output (MASTER).
2. $\overline{\text{BUSY}}$ is asserted on port "B" blocking $\text{R}/\overline{\text{W}}_{\text{B}}$, until $\overline{\text{BUSY}}_{\text{B}}$ goes HIGH.
3. t_{WB} only applies to the slave mode.

5632 drw 15

Waveform of **BUSY** Arbitration Controlled by **CE** Timing ($M/\overline{S} = V_{IH}$)⁽¹⁾Waveform of **BUSY** Arbitration Cycle Controlled by Address Match Timing ($M/\overline{S} = V_{IH}$)^(1,3,4)

NOTES:

1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".
2. If tAPS is not satisfied, the **BUSY** signal will be asserted on one side or another but there is no guarantee on which side **BUSY** will be asserted.
3. $\overline{CE}_X = V_{IL}$ when $\overline{CE}_{0X} = V_{IL}$ and $CE_{1X} = V_{IH}$. $\overline{CE}_X = V_{IH}$ when $\overline{CE}_{0X} = V_{IH}$ and/or $CE_{1X} = V_{IL}$.
4. $\overline{CE}_{0X} = \overline{OE}_X = \overline{BE}_{NX} = V_{IL}$. $CE_{1X} = V_{IH}$.

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range^(1,2)

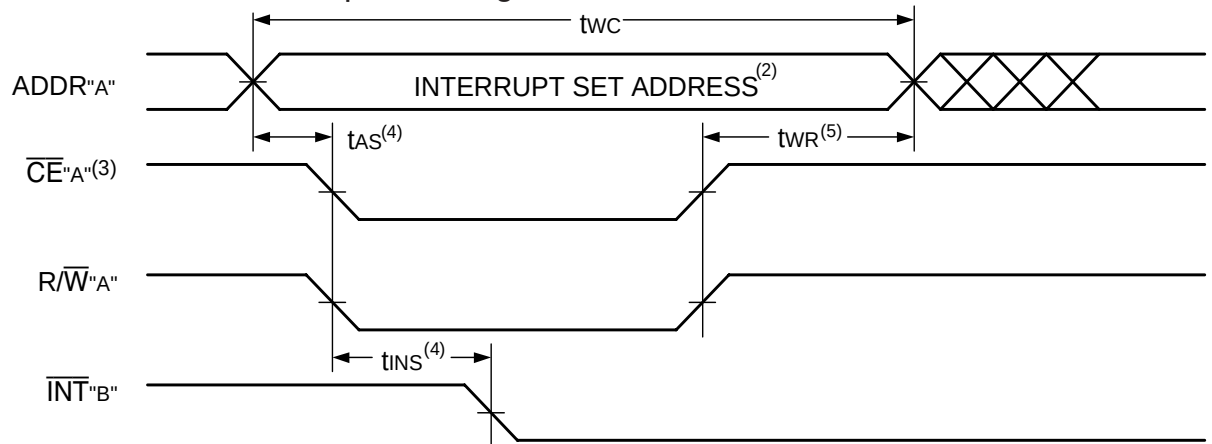
		70T651/9S10 Com'l Only		70T651/9S12 Com'l & Ind		70T651/9S15 Com'l Only		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
INTERRUPT TIMING								
tAS	Address Set-up Time	0	—	0	—	0	—	ns
tWR	Write Recovery Time	0	—	0	—	0	—	ns
tINS	Interrupt Set Time	—	10	—	12	—	15	ns
tINR	Interrupt Reset Time	—	10	—	12	—	15	ns

NOTES:

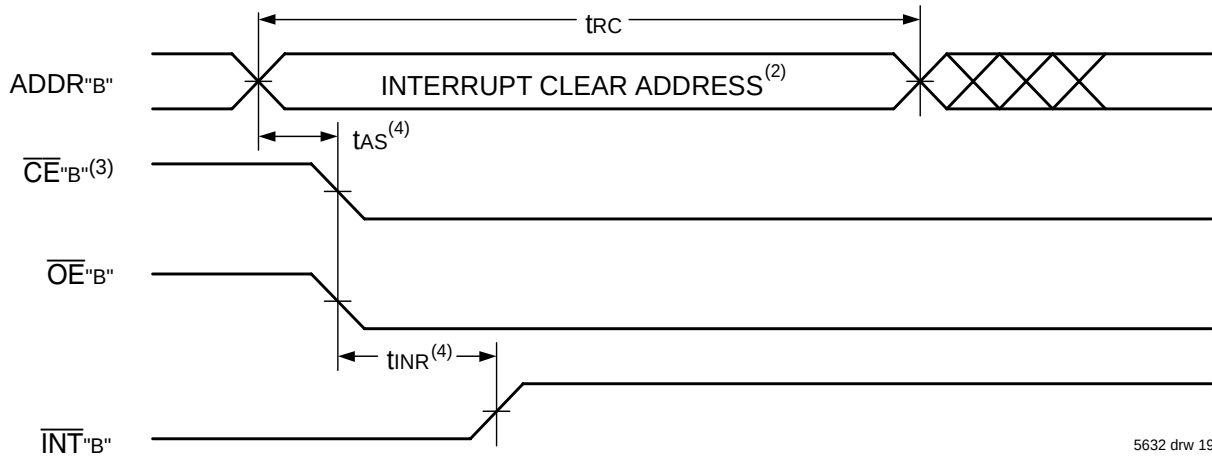
1. Timing is the same for both ports.
2. These values are valid regardless of the power supply level selected for I/O and control signals (3.3V/2.5V). See page 6 for details.
3. 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.

5632 tbl 16a

Waveform of Interrupt Timing⁽¹⁾



5632 drw 18



5632 drw 19

NOTES:

1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".
2. Refer to Interrupt Truth Table.
3. $\overline{CE}_x = V_{IL}$ means $\overline{CE}_{0x} = V_{IL}$ and $CE_{1x} = V_{IH}$. $\overline{CE}_x = V_{IH}$ means $\overline{CE}_{0x} = V_{IH}$ and/or $CE_{1x} = V_{IL}$.
4. Timing depends on which enable signal ($\overline{CE}$ or $R/\overline{W}$) is asserted last.
5. Timing depends on which enable signal ($\overline{CE}$ or $R/\overline{W}$) is de-asserted first.

Truth Table III — Interrupt Flag^(1,4)

Left Port					Right Port					Function
R/W _L	CE _L	OE _L	A _{17L} -A _{0L} ⁽⁵⁾	INT _L	R/W _R	CE _R	OE _R	A _{17R} -A _{0R} ⁽⁵⁾	INT _R	
L	L	X	3FFFF	X	X	X	X	X	L ⁽²⁾	Set Right INT _R Flag
X	X	X	X	X	X	L	L	3FFFF	H ⁽³⁾	Reset Right INT _R Flag
X	X	X	X	L ⁽³⁾	L	L	X	3FFFE	X	Set Left INT _L Flag
X	L	L	3FFFE	H ⁽²⁾	X	X	X	X	X	Reset Left INT _L Flag

5632 tbl 17

NOTES:

1. Assumes $\overline{BUSY}_L = \overline{BUSY}_R = V_{IH}$. $\overline{CE}_{0x} = V_{IL}$ and $CE_{1x} = V_{IH}$.
2. If $\overline{BUSY}_L = V_{IL}$, then no change.
3. If $\overline{BUSY}_R = V_{IL}$, then no change.
4. INT_L and INT_R must be initialized at power-up.
5. A_{17x} is a NC for IDT70T659. Therefore, Interrupt Addresses are 1FFFF and 1FFFE.

Truth Table IV —
Address **BUSY** Arbitration

Inputs			Outputs		Function
$\overline{CE}_L^{(5)}$	$\overline{CE}_R^{(5)}$	A _{0L} -A _{17L} ⁽⁴⁾ A _{0R} -A _{17R}	$\overline{BUSY}_L^{(1)}$	$\overline{BUSY}_R^{(1)}$	
X	X	NO MATCH	H	H	Normal
H	X	MATCH	H	H	Normal
X	H	MATCH	H	H	Normal
L	L	MATCH	(2)	(2)	Write Inhibit ⁽³⁾

5632 tbl 18

NOTES:

1. Pins $\overline{BUSY}_L$ and $\overline{BUSY}_R$ are both outputs when the part is configured as a master. Both are inputs when configured as a slave. $\overline{BUSY}$ outputs on the IDT70T651/9 are push-pull, not open drain outputs. On slaves the $\overline{BUSY}$ input internally inhibits writes.
2. "L" if the inputs to the opposite port were stable prior to the address and enable inputs of this port. "H" if the inputs to the opposite port became stable after the address and enable inputs of this port. If t_{APS} is not met, either $\overline{BUSY}_L$ or $\overline{BUSY}_R$ = LOW will result. $\overline{BUSY}_L$ and $\overline{BUSY}_R$ outputs can not be LOW simultaneously.
3. Writes to the left port are internally ignored when $\overline{BUSY}_L$ outputs are driving LOW regardless of actual logic level on the pin. Writes to the right port are internally ignored when $\overline{BUSY}_R$ outputs are driving LOW regardless of actual logic level on the pin.
4. A₁₇ is a NC for IDT70T659. Address comparison will be for A₀ - A₁₆.
5. $\overline{CE}_X$ = L means $\overline{CE}_{0X}$ = V_{IL} and CE_{1X} = V_{IH}. $\overline{CE}_X$ = H means $\overline{CE}_{0X}$ = V_{IH} and/or CE_{1X} = V_{IL}.

Truth Table V — Example of Semaphore Procurement Sequence^(1,2,3)

Functions	D ₀ - D ₃₅ Left	D ₀ - D ₃₅ Right	Status
No Action	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Left port has semaphore token
Right Port Writes "0" to Semaphore	0	1	No change. Right side has no write access to semaphore
Left Port Writes "1" to Semaphore	1	0	Right port obtains semaphore token
Left Port Writes "0" to Semaphore	1	0	No change. Left port has no write access to semaphore
Right Port Writes "1" to Semaphore	0	1	Left port obtains semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free
Right Port Writes "0" to Semaphore	1	0	Right port has semaphore token
Right Port Writes "1" to Semaphore	1	1	Semaphore free
Left Port Writes "0" to Semaphore	0	1	Left port has semaphore token
Left Port Writes "1" to Semaphore	1	1	Semaphore free

5632 tbl 19

NOTES:

1. This table denotes a sequence of events for only one of the eight semaphores on the IDT70T651/9.
2. There are eight semaphore flags written to via I/O₀ and read from all I/O's (I/O₀-I/O₃₅). These eight semaphores are addressed by A₀ - A₂.
3. $\overline{CE}$ = V_{IH}, $\overline{SEM}$ = V_{IL} to access the semaphores. Refer to the Semaphore Read/Write Control Truth Table.

Functional Description

The IDT70T651/9 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT70T651/9 has an automatic power down feature controlled by $\overline{CE}$. The $\overline{CE}_0$ and CE₁ control the on-chip power down circuitry that permits the respective port to go into a standby mode when not selected ($\overline{CE}$ = HIGH). When a port is enabled, access to the entire memory array is permitted.

Interrupts

If the user chooses the interrupt function, a memory location (mail

box or message center) is assigned to each port. The left port interrupt flag ($\overline{INT}_L$) is asserted when the right port writes to memory location 3FFFE (HEX), where a write is defined as $\overline{CE}_R$ = $\overline{R}/\overline{W}_R$ = V_{IL} per the Truth Table. The left port clears the interrupt through access of address location 3FFFE when $\overline{CE}_L$ = $\overline{O}_E_L$ = V_{IL}, $\overline{R}/\overline{W}$ is a "don't care". Likewise, the right port interrupt flag ($\overline{INT}_R$) is asserted when the left port writes to memory location 3FFFF (HEX) and to clear the interrupt flag ($\overline{INT}_R$), the right port must read the memory location 3FFFF. The message (36 bits) at 3FFFE or 3FFFF (1FFFF or 1FFFE for IDT70T659) is user-defined since it is an addressable SRAM location. If the interrupt function is not used, address locations 3FFFE and 3FFFF are not used

as mail boxes, but as part of the random access memory. Refer to Truth Table III for the interrupt operation.

Busy Logic

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "Busy". The $\overline{\text{BUSY}}$ pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a $\overline{\text{BUSY}}$ indication, the write signal is gated internally to prevent the write from proceeding.

The use of $\overline{\text{BUSY}}$ logic is not required or desirable for all applications. In some cases it may be useful to logically OR the $\overline{\text{BUSY}}$ outputs together and use any $\overline{\text{BUSY}}$ indication as an interrupt source to flag the event of an illegal or illogical operation. If the write inhibit function of $\overline{\text{BUSY}}$ logic is not desirable, the $\overline{\text{BUSY}}$ logic can be disabled by placing the part in slave mode with the $\text{M}/\overline{\text{S}}$ pin. Once in slave mode the $\overline{\text{BUSY}}$ pin operates solely as a write inhibit input pin. Normal operation can be programmed by tying the $\overline{\text{BUSY}}$ pins HIGH. If desired, unintended write operations can be prevented to a port by tying the $\overline{\text{BUSY}}$ pin for that port LOW.

The $\overline{\text{BUSY}}$ outputs on the IDT70T651/9 RAM in master mode, are push-pull type outputs and do not require pull up resistors to operate.

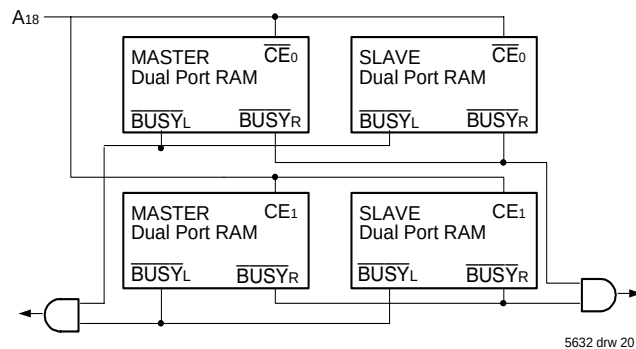


Figure 3. Busy and chip enable routing for both width and depth expansion with IDT70T651/9 Dual-Port RAMs.

If these RAMs are being expanded in depth, then the $\overline{\text{BUSY}}$ indication for the resulting array requires the use of an external AND gate.

Width Expansion with Busy Logic Master/Slave Arrays

When expanding an IDT70T651/9 RAM array in width while using $\overline{\text{BUSY}}$ logic, one master part is used to decide which side of the RAMs array will receive a $\overline{\text{BUSY}}$ indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master use the $\overline{\text{BUSY}}$ signal as a write inhibit signal. Thus on the IDT70T651/9 RAM the $\overline{\text{BUSY}}$ pin is an output if the part is used as a master ($\text{M}/\overline{\text{S}}$ pin = V_{IH}), and the $\overline{\text{BUSY}}$ pin is an input if the part is used as a slave ($\text{M}/\overline{\text{S}}$ pin = V_{IL}) as shown in Figure 3.

If two or more master parts were used when expanding in width, a split decision could result with one master indicating $\overline{\text{BUSY}}$ on one side of the array and another master indicating $\overline{\text{BUSY}}$ on one other side of the array. This would inhibit the write operations from one port for part of a word and inhibit the write operations from the other port for the other part of the word.

The $\overline{\text{BUSY}}$ arbitration on a master is based on the chip enable and address signals only. It ignores whether an access is a read or write. In a master/slave array, both address and chip enable must be valid long enough for a $\overline{\text{BUSY}}$ flag to be output from the master before the actual write pulse can be initiated with the $\text{R}/\overline{\text{W}}$ signal. Failure to observe this timing can result in a glitched internal write inhibit signal and corrupted data in the slave.

Semaphores

The IDT70T651/9 is an extremely fast Dual-Port 256/128K x 36 CMOS Static RAM with an additional 8 address locations dedicated to binary semaphore flags. These flags allow either processor on the left or right side of the Dual-Port RAM to claim a privilege over the other processor for functions defined by the system designer's software. As an example, the semaphore can be used by one processor to inhibit the other from accessing a portion of the Dual-Port RAM or any other shared resource.

The Dual-Port RAM features a fast access time, with both ports being completely independent of each other. This means that the activity on the left port in no way slows the access time of the right port. Both ports are identical in function to standard CMOS Static RAM and can be read from or written to at the same time with the only possible conflict arising from the simultaneous writing of, or a simultaneous READ/WRITE of, a non-semaphore location. Semaphores are protected against such ambiguous situations and may be used by the system program to avoid any conflicts in the non-semaphore portion of the Dual-Port RAM. These devices have an automatic power-down feature controlled by $\overline{\text{CE}}_0$ and CE_1 , the Dual-Port RAM chip enables, and $\overline{\text{SEM}}$, the semaphore enable. The $\overline{\text{CE}}_0$, CE_1 , and $\overline{\text{SEM}}$ pins control on-chip power down circuitry that permits the respective port to go into standby mode when not selected.

Systems which can best use the IDT70T651/9 contain multiple processors or controllers and are typically very high-speed systems which are software controlled or software intensive. These systems can benefit from a performance increase offered by the IDT70T651/9s hardware semaphores, which provide a lockout mechanism without requiring complex programming.

Software handshaking between processors offers the maximum in system flexibility by permitting shared resources to be allocated in varying configurations. The IDT70T651/9 does not use its semaphore flags to control any resources through hardware, thus allowing the system designer total flexibility in system architecture.

An advantage of using semaphores rather than the more common methods of hardware arbitration is that wait states are never incurred in either processor. This can prove to be a major advantage in very high-speed systems.

How the Semaphore Flags Work

The semaphore logic is a set of eight latches which are independent of the Dual-Port RAM. These latches can be used to pass a flag, or token, from one port to the other to indicate that a shared resource is in use. The semaphores provide a hardware assist for a use assignment method called "Token Passing Allocation." In this method, the state of a semaphore latch is used as a token indicating that a shared resource is in use. If the left processor wants to use this resource, it requests the token by setting the latch. This processor then

verifies its success in setting the latch by reading it. If it was successful, it proceeds to assume control over the shared resource. If it was not successful in setting the latch, it determines that the right side processor has set the latch first, has the token and is using the shared resource. The left processor can then either repeatedly request that semaphore's status or remove its request for that semaphore to perform another task and occasionally attempt again to gain control of the token via the set and test sequence. Once the right side has relinquished the token, the left side should succeed in gaining control.

The semaphore flags are active LOW. A token is requested by writing a zero into a semaphore latch and is released when the same side writes a one to that latch.

The eight semaphore flags reside within the IDT70T651/9 in a separate memory space from the Dual-Port RAM. This address space is accessed by placing a low input on the $\overline{\text{SEM}}$ pin (which acts as a chip select for the semaphore flags) and using the other control pins (Address, $\overline{\text{CE}}_0$, CE_1 , $\text{R}/\overline{\text{W}}$ and $\overline{\text{BEN}}$) as they would be used in accessing a standard Static RAM. Each of the flags has a unique address which can be accessed by either side through address pins A_0 – A_2 . When accessing the semaphores, none of the other address pins has any effect.

When writing to a semaphore, only data pin D_0 is used. If a low level is written into an unused semaphore location, that flag will be set to a zero on that side and a one on the other side (see Truth Table V). That semaphore can now only be modified by the side showing the zero. When a one is written into the same location from the same side, the flag will be set to a one for both sides (unless a semaphore request from the other side is pending) and then can be written to by both sides. The fact that the side which is able to write a zero into a semaphore subsequently locks out writes from the other side is what makes semaphore flags useful in interprocessor communications. (A thorough discussion on the use of this feature follows shortly.) A zero written into the same location from the other side will be stored in the semaphore request latch for that side until the semaphore is freed by the first side.

When a semaphore flag is read, its value is spread into all data bits so that a flag that is a one reads as a one in all data bits and a flag containing a zero reads as all zeros for a semaphore read, the $\overline{\text{SEM}}$, $\overline{\text{BEN}}$, and $\overline{\text{OE}}$ signals need to be active. (Please refer to Truth Table II). Furthermore, the read value is latched into one side's output register when that side's semaphore select ($\overline{\text{SEM}}$, $\overline{\text{BEN}}$) and output enable ($\overline{\text{OE}}$) signals go active. This serves to disallow the semaphore from changing state in the middle of a read cycle due to a write cycle from the other side.

A sequence WRITE/READ must be used by the semaphore in order to guarantee that no system level contention will occur. A processor requests access to shared resources by attempting to write a zero into a semaphore location. If the semaphore is already in use, the semaphore request latch will contain a zero, yet the semaphore flag will appear as one, a fact which the processor will verify by the subsequent read (see Table V). As an example, assume a processor writes a zero to the left port at a free semaphore location. On a subsequent read, the processor will verify that it has written successfully to that location and will assume control over the resource in question. Meanwhile, if a processor on the right side attempts to write a zero to the same semaphore flag it will fail, as will be verified by the fact that a one will be read from that semaphore on the right side during subsequent read. Had a sequence of READ/WRITE been used instead, system contention problems could have occurred during

the gap between the read and write cycles.

It is important to note that a failed semaphore request must be followed by either repeated reads or by writing a one into the same location. The reason for this is easily understood by looking at the simple logic diagram of the semaphore flag in Figure 4. Two semaphore request latches feed into a semaphore flag. Whichever latch is first to present a zero to the semaphore flag will force its side of the semaphore flag LOW and the other side HIGH. This condition will continue until a one is written to the same semaphore request latch. If the opposite side semaphore request latch has been written to zero in the meantime, the semaphore flag will flip over to the other side as soon as a one is written into the first request latch. The opposite side flag will now stay LOW until its semaphore request latch is written to a one. From this it is easy to

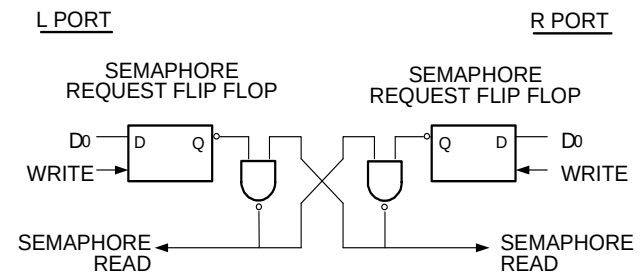


Figure 4. IDT70T651/9 Semaphore Logic

5632 drw 21

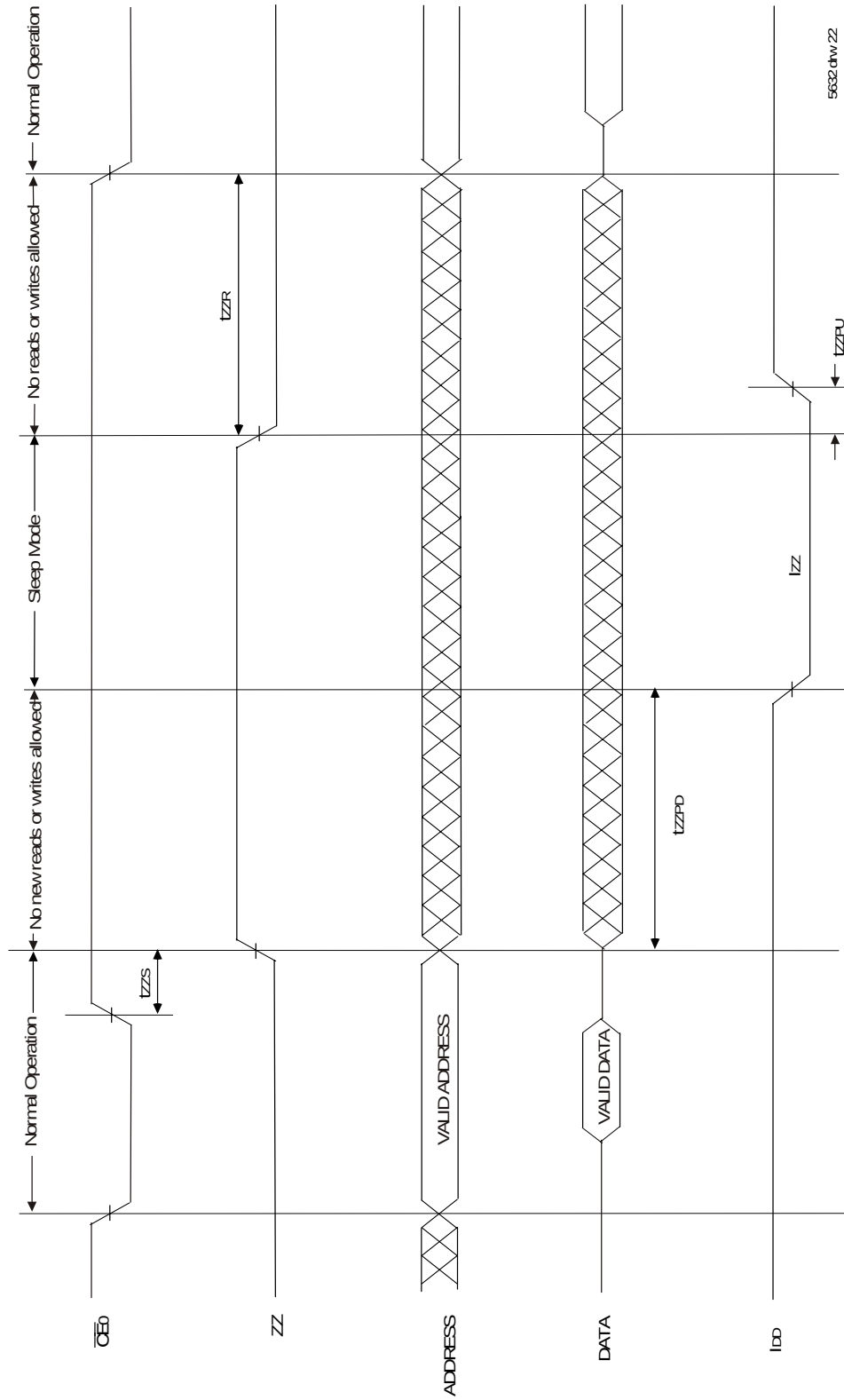
understand that, if a semaphore is requested and the processor which requested it no longer needs the resource, the entire system can hang up until a one is written into that semaphore request latch.

The critical case of semaphore timing is when both sides request a single token by attempting to write a zero into it at the same time. The semaphore logic is specially designed to resolve this problem. If simultaneous requests are made, the logic guarantees that only one side receives the token. If one side is earlier than the other in making the request, the first side to make the request will receive the token. If both requests arrive at the same time, the assignment will be arbitrarily made to one port or the other.

One caution that should be noted when using semaphores is that semaphores alone do not guarantee that access to a resource is secure. As with any powerful programming technique, if semaphores are misused or misinterpreted, a software error can easily happen.

Initialization of the semaphores is not automatic and must be handled via the initialization program at power-up. Since any semaphore request flag which contains a zero must be reset to a one, all semaphores on both sides should have a one written into them at initialization from both sides to assure that they will be free when needed.

Timing Waveform of Sleep Mode^(1,2)



NOTES:

1. CE1 = VIH.
2. All timing is same for Left and Right ports.

Sleep Mode

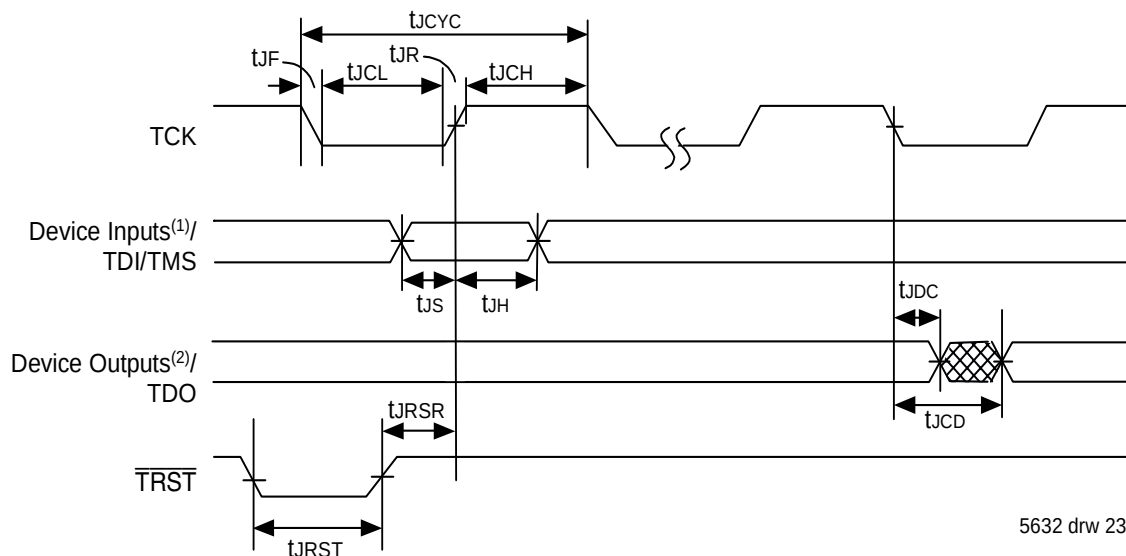
The IDT70T651/9 is equipped with an optional sleep or low power mode on both ports. The sleep mode pin on both ports is active high. During normal operation, the ZZ pin is pulled low. When ZZ is pulled high, the port will enter sleep mode where it will meet lowest possible power conditions. The sleep mode timing diagram shows the modes of operation: Normal Operation, No Read/Write Allowed and Sleep Mode.

For a period of time prior to sleep mode and after recovering from sleep mode (t_{zts} and t_{ztr}), new reads or writes are not allowed. If a write or read

operation occurs during these periods, the memory array may be corrupted. Validity of data out from the RAM cannot be guaranteed immediately after ZZ is asserted (prior to being in sleep).

During sleep mode the RAM automatically deselects itself. The RAM disconnects its internal buffer. All outputs will remain in high-Z state while in sleep mode. All inputs are allowed to toggle. The RAM will not be selected and will not perform any reads or writes.

JTAG Timing Specifications



NOTES:

1. Device inputs = All device inputs except TDI, TMS, TCK and $\overline{\text{TRST}}$.
2. Device outputs = All device outputs except TDO.

JTAG AC Electrical Characteristics^(1,2,3,4,5)

Symbol	Parameter	70T651/9		
		Min.	Max.	Units
t_{JCyc}	JTAG Clock Input Period	100	—	ns
t_{JCH}	JTAG Clock HIGH	40	—	ns
t_{JCL}	JTAG Clock Low	40	—	ns
t_{JR}	JTAG Clock Rise Time	—	3 ⁽¹⁾	ns
t_{JF}	JTAG Clock Fall Time	—	3 ⁽¹⁾	ns
t_{JRST}	JTAG Reset	50	—	ns
t_{JRSR}	JTAG Reset Recovery	50	—	ns
t_{JCD}	JTAG Data Output	—	25	ns
t_{JDC}	JTAG Data Output Hold	0	—	ns
t_{JS}	JTAG Setup	15	—	ns
t_{JH}	JTAG Hold	15	—	ns

NOTES:

1. Guaranteed by design.
2. 30pF loading on external output signals.
3. Refer to AC Electrical Test Conditions stated earlier in this document.
4. JTAG operations occur at one speed (10MHz). The base device may run at any speed specified in this datasheet.
5. JTAG cannot be tested in sleep mode.

Identification Register Definitions

Instruction Field	Value	Description
Revision Number (31:28)	0x0	Reserved for version number
IDT Device ID (27:12)	0x338 ⁽¹⁾	Defines IDT part number 70T651
IDT JEDEC ID (11:1)	0x33	Allows unique identification of device vendor as IDT
ID Register Indicator Bit (Bit 0)	1	Indicates the presence of an ID register

5632 tbl 21

NOTE:

1. Device ID for IDT70T659 is 0x339.

Scan Register Sizes

Register Name	Bit Size
Instruction (IR)	4
Bypass (BYR)	1
Identification (IDR)	32
Boundary Scan (BSR)	Note (3)

5632 tbl 22

System Interface Parameters

Instruction	Code	Description
EXTEST	0000	Forces contents of the boundary scan cells onto the device outputs ⁽¹⁾ . Places the boundary scan register (BSR) between TDI and TDO.
BYPASS	1111	Places the bypass register (BYR) between TDI and TDO.
IDCODE	0010	Loads the ID register (IDR) with the vendor ID code and places the register between TDI and TDO.
HIGHZ	0100	Places the bypass register (BYR) between TDI and TDO. Forces all device output drivers to a High-Z state.
CLAMP	0011	Uses BYR. Forces contents of the boundary scan cells onto the device outputs. Places the bypass register (BYR) between TDI and TDO.
SAMPLE/PRELOAD	0001	Places the boundary scan register (BSR) between TDI and TDO. SAMPLE allows data from device inputs ⁽²⁾ and outputs ⁽¹⁾ to be captured in the boundary scan cells and shifted serially through TDO. PRELOAD allows data to be input serially into the boundary scan cells via the TDI.
RESERVED	All Other Codes	Several combinations are reserved. Do not use codes other than those identified above.

5632 tbl 23

NOTES:

1. Device outputs = All device outputs except TDO.
2. Device inputs = All device inputs except TDI, TMS, TCK and $\overline{\text{TRST}}$.
3. The Boundary Scan Descriptive Language (BSDL) file for this device is available on the IDT website (www.idt.com), or by contacting your local IDT sales representative.

Ordering Information

XXXXX	A	999	A	A	A	A		
Device Type	Power	Speed	Package		Process/ Temperature Range			
							Blank 8	Tube of Tray Tape and Reel
							Blank 1 ⁽³⁾	Commercial (0°C to +70°C) Industrial (-40°C to +85°C)
							G ⁽²⁾	Green
							BC DR BF	256-pin BGA (BC-256) 208-pin PQFP (DR-208) 208-pin fpBGA (BF-208)
							10 12 15	Commercial & Industrial ⁽¹⁾ Commercial & Industrial Commercial Only
							S	Standard Power
							70T651 70T659	9Mbit (256K x 36) Asynchronous Dual-Port RAM 4Mbit (128K x 36) Asynchronous Dual-Port RAM

5632 drw 24

NOTES:

- 10ns Industrial speed grade is available in BF-208 and BC-256 packages only.
- Green parts available. For specific speeds, packages and powers contact your local sales office.
LEAD FINISH (SnPb) parts are in EOL process. Product Discontinuation Notice - PDN# SP-17-02
- Contact your local sales office for additional industrial temp range speeds, packages and powers.

Datasheet Document History

04/25/03:		Initial Datasheet
10/01/03:	Page 9	Added 8ns speed DC power numbers to DC Electrical Characteristics Table
	Page 9	Updated DC power numbers for 10, 12 & 15ns speeds in the DC Electrical Characteristics Table
	Page 9, 11, 15, 17 & 26	Added footnote that indicates that 8ns speed is available in BF-208 and BC-256 packages only
	Page 10	Added Capacitance Derating Drawing
	Page 11, 15 & 17	Added 8ns AC timing numbers to the AC Electrical Characteristics Tables
	Page 11	Added t _{SOE} and t _{LZOB} to the AC Read Cycle Electrical Characteristics Table
	Page 12	Added t _{LZOB} to the Waveform of Read Cycles Drawing
	Page 14	Added t _{SOE} to Timing Waveform of Semaphore Read after Write Timing, Either Side Drawing
	Page 1 & 25	Added 8ns speed grade and 10ns I-temp to features and to ordering information
	Page 1, 14 & 15	Added RapidWrite Mode Write Cycle text and waveforms
10/20/03:	Page 15	Corrected t _{ARF} to 1.5V/ns Min.
04/21/04:		Removed Preliminary status from entire datasheet
01/05/06:	Page 1	Added green availability to features
	Page 27	Added green indicator to ordering information

Datasheet Document History (con't)

07/25/08:	Page 9	Corrected a typo in the DC Chars table
01/19/09:	Page 27	Removed "IDT" from orderable part number
06/22/15:	Page 2 , 3 & 4	Removed the date from all of the pin configurations BC-256, DR-208 & BF-208
	Page 27	Added T&R indicator and updated footnotes to Ordering Information
07/20/15:	Page 1	Updated the commercial speed offering by removing the 8ns speed
	Page 9	Removed commercial 8ns speed from DC Elec Chars table and edited footnotes to reflect this change
	Page 11 & 17	Removed commercial 8ns speed from all AC Elec Chars tables and edited footnotes to reflect this change
	Page 27	Removed commercial 8ns speed offering from the Ordering Information
11/28/17:		Product Discontinuation Notice - PDN# SP-17-02
		Last time buy expires June 15, 2018



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